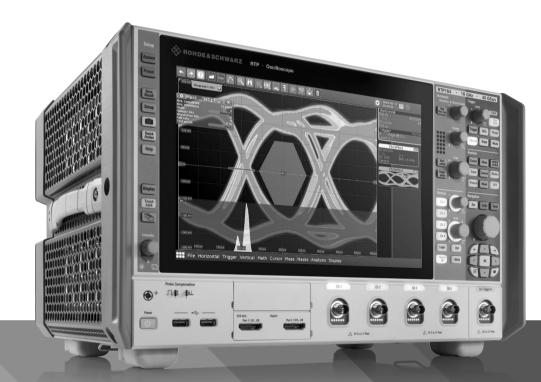
# R&S®RTP HIGH-PERFORMANCE OSCILLOSCOPE



**Specifications** 



Data Sheet

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#### **Definitions**

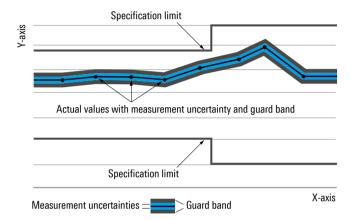
#### General

Product data applies under the following conditions:

- Three hours storage at ambient temperature followed by 30 minutes warm-up operation
- Specified environmental conditions met
- · Recommended calibration interval adhered to
- · All internal automatic adjustments performed, if applicable

#### Specifications with limits

Represent warranted product performance by means of a range of values for the specified parameter. These specifications are marked with limiting symbols such as <,  $\leq$ ,  $\geq$ ,  $\pm$ , or descriptions such as maximum, limit of, minimum. Compliance is ensured by testing or is derived from the design. Test limits are narrowed by guard bands to take into account measurement uncertainties, drift and aging, if applicable.



#### Non-traceable specifications with limits (n. trc.)

Represent product performance that is specified and tested as described under "Specifications with limits" above. However, product performance in this case cannot be warranted due to the lack of measuring equipment traceable to national metrology standards. In this case, measurements are referenced to standards used in the Rohde & Schwarz laboratories.

#### Specifications without limits

Represent warranted product performance for the specified parameter. These specifications are not specially marked and represent values with no or negligible deviations from the given value (e.g. dimensions or resolution of a setting parameter). Compliance is ensured by design.

#### Typical data (typ.)

Characterizes product performance by means of representative information for the given parameter. When marked with <, > or as a range, it represents the performance met by approximately 80 % of the instruments at production time. Otherwise, it represents the mean value.

#### Nominal values (nom.)

Characterize product performance by means of a representative value for the given parameter (e.g. nominal impedance). In contrast to typical data, a statistical evaluation does not take place and the parameter is not tested during production.

#### Measured values (meas.)

Characterize expected product performance by means of measurement results gained from individual samples.

#### Uncertainties

Represent limits of measurement uncertainty for a given measurand. Uncertainty is defined with a coverage factor of 2 and has been calculated in line with the rules of the Guide to the Expression of Uncertainty in Measurement (GUM), taking into account environmental conditions, aging, wear and tear.

Device settings and GUI parameters are designated with the format "parameter: value".

Non-traceable specifications with limits, typical data as well as nominal and measured values are not warranted by Rohde & Schwarz.

In line with the 3GPP/3GPP2 standard, chip rates are specified in million chips per second (Mcps), whereas bit rates and symbol rates are specified in billion bits per second (Gbps), million bits per second (Mbps), thousand bits per second (kbps), million symbols per second (Msps) or thousand symbols per second (ksps), and sample rates are specified in million samples per second (Msample/s). Gbps, Mcps, Mbps, Msps, ksps and Msample/s are not SI units.

### Base unit

## **Vertical system**

Input channels		4 channels	
Input impedance	offset and position set to zero	50 Ω ± 2 %	
Analog bandwidth (–3 dB)	R&S®RTP044	≥ 4 GHz	
rulaiog banamati ( o ab)	R&S®RTP064	≥ 6 GHz	
	R&S®RTP084	≥ 8 GHz	
	R&S®RTP134	≥ 13 GHz on 2 channels,	
	NGO KII 104	≥ 8 GHz on 4 channels	
	R&S®RTP164	≥ 16 GHz on 2 channels.	
	104	≥ 8 GHz on 4 channels	
Rise time/fall time	10 % to 90 %, calculated from 0.		
NGC time/rail time	R&S®RTP044	108 ps	
	R&S®RTP064	72 ps	
	R&S®RTP084		
		54 ps	
	R&S®RTP134	33 ps	
	R&S®RTP164	27 ps	
Vertical resolution		8 bit,	
		16 bit for high resolution decimation	
		(with reduction of the sampling rate),	
		16 bit for high definition mode (without reduction of the	
		sampling rate 1)	
DC gain accuracy	offset and position set to zero		
	> 5 mV/div	±1.5 %	
	≤ 5 mV/div	±2 %	
Input coupling		DC	
Input sensitivity	entire analog bandwidth	2 mV/div to 1 V/div	
	supported for all input		
	sensitivities		
	in high definition mode	1 mV/div to 1 V/div	
Maximum input voltage		±5 V	
Position range		±5 div	
Offset range	input sensitivity		
_	> 100 mV/div	±5 V	
	≤ 100 mV/div	±(1.5 V – input sensitivity × 5 div)	
Offset accuracy	input sensitivity		
,	> 100 mV/div	±(0.35 % ×  net offset	
	≤ 100 mV/div. net offset		
		, ,	
	> 1 V	,	
	net offset = offset – position × input sensitivity		
DC measurement accuracy			
Channel-to-channel isolation		· · · · · · · · · · · · · · · · · · ·	
		- 55 db (typ.)	
sensitivity) between channels 1-2 and 3-4 > 40 dB (typ.)		> 40 dB (typ.)	
DC measurement accuracy  Channel-to-channel isolation (each channel at same input	input sensitivity  > 100 mV/div  ≤ 100 mV/div, net offset ≤ 1 V  ≤ 100 mV/div, net offset > 1 V  net offset = offset – position × input after adequate suppression of measurement noise  between channels 1-3, 1-4, 2-3, 2-4	±(0.35 % ×  net offset  + 0.1 div × input sensitivity)  ±(0.35 % ×  net offset  + 0.1 div × input sensitivity + 2 mV)  ±1 % ×  net offset   put sensitivity  ±(DC gain accuracy ×  reading – net offset  + offset accuracy)  > 60 dB (typ.)	

 $<sup>^{\</sup>rm 1}$   $\,$  The maximum realtime sampling rate of the high definition mode is 10 Gsample/s.

RMS noise floor (meas.)	input sensitivity	R&S®RTP044	R&S®RTP064
(corresponding signal to noise	2 mV/div	270 μV (28.3 dB)	340 μV (26.3 dB)
ratio at full scale (calculated))	5 mV/div	280 μV (36.0 dB)	360 μV (33.8 dB)
	10 mV/div	410 μV (38.7 dB)	500 μV (37.0 dB)
	20 mV/div	630 μV (41.0 dB)	750 μV (39.5 dB)
	50 mV/div	1.4 mV (42.0 dB)	1.7 mV (40.3 dB)
	100 mV/div	2.7 mV (42.3 dB)	3.1 mV (41.1 dB)
	200 mV/div	6.6 mV (40.6 dB)	8.2 mV (38.7 dB)
	500 mV/div	14 mV (42.0 dB)	17 mV (40.3 dB)
	1 V/div	27 mV (42.3 dB)	32 mV (40.9 dB)
	input sensitivity	R&S®RTP084	R&S®RTP134
	2 mV/div	430 μV (24.3 dB)	670 μV (20.5 dB)
	5 mV/div	440 μV (32.1 dB)	720 μV (27.8 dB)
	10 mV/div	620 μV (35.1 dB)	900 μV (31.9 dB)
	20 mV/div	880 μV (38.1 dB)	1.3 mV (34.7 dB)
	50 mV/div	2.0 mV (38.9 dB)	2.7 mV (36.3 dB)
	100 mV/div	3.6 mV (39.8 dB)	4.3 mV (38.3 dB)
	200 mV/div	9.8 mV (37.2 dB)	12 mV (35.4 dB)
	500 mV/div	21 mV (38.5 dB)	27 mV (36.3 dB)
	1 V/div	36 mV (39.8 dB)	43 mV (38.3 dB)
	input sensitivity	R&S®RTP164	
	2 mV/div	840 μV (18.5 dB)	
	5 mV/div	900 μV (25.9 dB)	
	10 mV/div	1.15 mV (29.8 dB)	
	20 mV/div	1.5 mV (33.5 dB)	
	50 mV/div	3.4 mV (34.3 dB)	
	100 mV/div	5.2 mV (36.6 dB)	
	200 mV/div	14 mV (34.1 dB)	
	500 mV/div	32 mV (34.8 dB)	
	1 V/div	48 mV (37.3 dB)	

# **Horizontal system**

Timebase range		selectable between 20 ps/div and 10 000 s/div.
		time per div settable to any value within
		range
Channel deskew		±100 ns
Reference position		0 % to 100 % of measurement display
		area
Trigger offset range	max.	+(memory depth/current sampling rate)
	min.	-10 000 s
Modes		normal, roll
Channel-to-channel skew		< 10 ps (meas.)
Timebase accuracy	after delivery/calibration, at +23 °C	±10 ppb
	during calibration interval	±100 ppb
	long-term stability	$\pm$ (50 + 50 × years since calibration) ppb
	(more than one year since calibration)	
Sample clock jitter	acquired time range	RMS value (meas.)
	1 μs	50 fs
	10 μs	63 fs
	100 μs	72 fs
	1 ms	76 fs
	10 ms	124 fs
Intrinsic jitter	RMS value	200 fs (meas.)
Time interval error (TIE)	RMS values	$\sqrt{\text{(Noise/SlewRate)}^2 + (Intrinsic Jitter)^2}$
Periodic jitter	RMS values	$\sqrt{2}\sqrt{(\text{Noise/SlewRate})^2 + (\text{Intrinsic Jitter})^2}$
Cycle-to-cycle jitter	RMS values	$\sqrt{3}\sqrt{\text{(Noise/SlewRate)}^2 + \text{(Intrinsic Jitter)}^2}$

### **Acquisition system**

Realtime sampling rate		max. 20 Gsample/s on 4 channels,
Realtime waveform acquisition rate	max.	max. 40 Gsample/s on 2 channels > 750 000 waveforms/s
Memory depth <sup>2</sup>	standard	50 Msample on 4 channels
метноту аерит	Standard	100 Msample on 2 channels
		200 Msample on 1 channel
	R&S®RTP-B101 option	100 Msample on 4 channels
	RAS KIF-BIOT OPHOLI	200 Msample on 2 channels
	R&S®RTP-B102 option	400 Msample on 1 channel
	R&S RTP-BT02 Option	200 Msample on 4 channels 400 Msample on 2 channels
		800 Msample on 1 channel
	R&S®RTP-B105 option	•
	R&S°R1P-B105 option	500 Msample on 4 channels
		1 Gsample on 2 channels
	D00@DTD D440	2 Gsample on 1 channel
	R&S®RTP-B110 option	1 Gsample on 4 channels
B 11 11 11 11 11 11 11 11 11 11 11 11 11		2 Gsample on 2 channels
Realtime digital filters	selectable for the data acquisition and/or	
	lowpass for acquisition system	cutoff frequency selectable from 100 kHz
		to 500 MHz
	lowpass for acquisition and trigger	cutoff frequency selectable from 1 GHz to
	system	the analog bandwidth with fine granularity
Decimation modes	sample	first sample in decimation interval
	peak detect	largest and smallest sample in decimation interval
	high resolution	average value of samples in decimation interval
	root mean square	root of squared average of samples in decimation interval
Waveform arithmetic	off	no arithmetic
	envelope	envelope of acquired waveforms
	average	average of acquired waveforms,
	a	max. average depth depends on
		decimation mode <sup>3</sup>
	sample	max. 16 777 215
	high resolution	max. 65 535
	root mean square	max. 255
	reset condition	no reset (standard), reset by time, reset
		by number of processed waveforms
Waveform streams per channel		up to 3 with independent selection of
Travolomi Giloamo por Gilamio.		decimation mode and waveform arithmetic
Sampling modes	realtime mode	max. sampling rate set by digitizer
Camping modes	interpolated time	enhancement of sampling resolution by
	interpolated time	interpolation; max. equivalent sampling rate is 5 Tsample/s
Interpolation modes		linear, sin(x)/x, sample&hold
Ultra-segmented mode	continuous recording of waveforms in acquisitation	uisition memory without interruption due to
	max. realtime waveform acquisition	> 3 000 000 waveforms/s
	rate min. blind time between consecutive acquisitions	< 350 ns

<sup>&</sup>lt;sup>2</sup> The maximum available memory depth depends on the bit depth of the acquired data and, therefore, on the settings of the acquisition system, such as decimation mode, waveform arithmetic, number of waveform streams and high definition mode.

 $<sup>^{\</sup>rm 3}$   $\,$  Waveform averaging is not compatible with peak detect decimation.

## **Differential signals**

General description	Calculation of differential and common mode signals from p part and n part connected to separate input channels. Because of the R&S®RTP digital trigger concept, these signals can be used as a trigger input.	
Input channels		channel 1, channel 2, channel 3, channel 4
Differential signal		difference between any two input channels
Common mode signal		sum of any two input channels
Maximum number of outputs 4	differential signals	2
	common mode signals	2

# High definition mode

General description	using digital filtering, leading to a	The high definition mode increases the numeric resolution of the waveform signal by using digital filtering, leading to a reduced noise. Because of the R&S®RTP digital trigger concept, the signals with increased numeric resolution are used as input for triggering.	
Numeric resolution	bandwidth	resolution	
	10 kHz to 200 MHz	16 bit	
	300 MHz	12 bit	
	500 MHz	12 bit	
	1 GHz	11 bit	
	2 GHz	10 bit	
Realtime sampling rate		max. 10 Gsample/s on each channel	

# **Trigger system**

Sources		channel 1, channel 2, channel 3,
		channel 4, inverted channels, external
		trigger, line trigger, differential, common
		mode
Sensitivity		10 <sup>-4</sup> div, from DC to instrument bandwidth
		for all vertical scales
Trigger jitter	full-scale sine wave of frequency set to  –3 dB bandwidth	< 1 ps (RMS) (meas.)
Coupling mode	standard	same as selected channel
	lowpass filter	cutoff frequency selectable from 1 GHz to
		analog bandwidth
Sweep mode		auto, normal, single, n single
Event rate	max.	one event for every 200 ps time interval
Trigger level	range	±5 div from center of screen
Trigger hysteresis	modes	auto (standard) or manual
	sensitivity	10 <sup>-4</sup> div, from DC to instrument bandwidth
		for all vertical scales
Holdoff range	time	100 ns to 10 s, fixed and random
	events	1 event to 2 000 000 000 events

<sup>&</sup>lt;sup>4</sup> Together with R&S®RTP-K122 realtime deembedding only one output can be calculated, differential or common mode.

Main trigger modes			
Edge	triggers on specified slope (pos	triggers on specified slope (positive, negative or either) and level	
Glitch	triggers on glitches of positive, specified width	negative or either polarity that are shorter or longer than	
	glitch width	25 ps to 10 000 s	
Width	Width triggers on positive or negative pulse of specified width; width can be inside or outside the interval		
	pulse width	25 ps to 10 000 s	
Runt	fails to cross a second thresho	triggers on pulse of positive, negative or either polarity that crosses one threshold but fails to cross a second threshold before crossing the first one again; runt pulse width	
	can be arbitrary, shorter, longe		
	runt pulse width	25 ps to 10 000 s	
Window		exits a specified voltage range; triggers also when signal	
		age range for a specified period of time	
Timeout	triggers when signal stays high	n, low or unchanged for a specified period of time	
	timeout	25 ps to 10 000 s	
Interval	triggers when time between two	o consecutive edges of same slope (positive or	
	negative) is shorter, longer, ins	side or outside a specified range	
	interval time	25 ps to 10 000 s	
Slew rate	triggers when the time required	triggers when the time required by a signal edge to toggle between user-defined upper	
	and lower voltage levels is sho	orter, longer, inside or outside the interval; edge slope	
	may be positive, negative or ei	ither	
	toggle time	25 ps to 10 000 s	
Data2clock	triggers on setup time and hold	triggers on setup time and hold time violations between clock and data present on any	
		two input channels; monitored time interval may be specified by the user in the range	
	from -100 ns to 100 ns around	from -100 ns to 100 ns around a clock edge and must be at least 100 ps wide	
Pattern		triggers when a logical combination (and, nand, or, nor) of the input channels stays true	
		nger, inside or outside a specified range	
State		ation (and, nand, or, nor) of the input channels stays true	
		r either) in one selected channel	

Advanced trigger modes			
Trigger qualification	trigger events may be qualified by a logical combination of unused channels		
	qualifiable events	edge, glitch, width, runt, window, timeout, interval	
Sequence trigger (A/B/R trigger)	triggers on B event after occurrence of A event; delay condition after A event specified either as time interval or number of B events; an optional R event resets the trigger sequence to A		
	A event	any trigger mode	
	B event	edge, glitch, width, runt, window, timeout, interval, slew rate	
	R event	edge, glitch, width, runt, window, timeout, interval, slew rate	
Zone trigger		with R&S®RTP-K19 option	
External trigger input	input impedance	50 Ω (nom.)	
	max. input voltage	5 V (RMS)	
	trigger level range	±5 V	
	sensitivity, for input frequency ≤ 500 MHz	300 mV (peak-to-peak)	
	input coupling	50 Ω, GND,	
		HF reject (attenuates > 50 kHz),	
		LF reject (attenuates < 50 kHz)	
	trigger modes	edge (rise or fall)	
Trigger out	functionality	a pulse is generated for every acquisition trigger event	
	output voltage	0 V to 5 V at high impedance	
		0 V to 2.5 V at 50 Ω	
	pulse width	selectable between 4 ns and 60 ms	
	pulse polarity	low active or high active	
	output delay	depends on trigger settings	
	jitter	±600 ps (meas.)	

## RF characteristics <sup>5</sup>

Sensitivity/noise density	at 1.001 GHz (measurement of the power spectral density at 1.001 GHz at input sensitivity 2 mV/div, corresponding to –30 dBm input range of the oscilloscope, using the FFT with center frequency 1.001 GHz, span	-157 dBm (1 Hz) (meas.)
Noise figure	500 kHz, RBW 3 kHz) at 1.001 GHz (calculated based on the noise density	17 dB (meas.)
Dynamic range	above)  measured for an input carrier with frequency 1 GHz and level –1 dBm at input sensitivity 70 mV/div, corresponding to 0 dBm input range of the oscilloscope, using the FFT with center frequency 1 GHz, span 100 MHz, RBW 400 Hz at +20 MHz from the center frequency	107 dB (meas.)
Absolute amplitude accuracy	input frequency	
•	≤ 12 GHz	±0.25 dB (meas.)
	> 12 GHz to ≤ 15 GHz	±0.5 dB (meas.)
Phase noise	at 1 GHz	
	10 kHz offset	-118 dBc (1 Hz) (meas.)
	100 kHz offset	-126 dBc (1 Hz) (meas.)
EVM	802.11, 20 MHz bandwidth, 64 QAM	
	802.11n, 2.4 GHz carrier	-46 dB (meas.)
	802.11ac, 5.7 GHz carrier	-44 dB (meas.)
Spurious-free dynamic range	measured for an input carrier with	66 dB (meas.)
(excl. harmonics)	frequency 950 MHz and level –1 dBm at input sensitivity 70 mV/div, corresponding to 0 dBm input range of the oscilloscope, using the FFT with center frequency	
Second harmonic distortion	3 GHz, span 5 GHz, RBW 100 kHz measured for an input carrier with frequency 950 MHz and level –1 dBm at input sensitivity 70 mV/div, corresponding to 0 dBm input range of the oscilloscope, using the FFT with center frequency 3 GHz, span 5 GHz, RBW 100 kHz	-52 dBc (meas.)
Third harmonic distortion	measured for an input carrier with frequency 950 MHz and level –1 dBm at input sensitivity 70 mV/div, corresponding to 0 dBm input range of the oscilloscope, using the FFT with center frequency 3 GHz, span 5 GHz, RBW 100 kHz	-43 dBc (meas.)
Third-order intercept point (TOI)	measured for two input tones with frequencies 2.436 GHz and 2.438 GHz and level 0 dBm at input sensitivity 160 mV/div, corresponding to 8 dBm input range of the oscilloscope, using the FFT with center frequency 2.437 GHz, span 10 MHz, RBW 30 kHz	23.5 dBm (meas.)
Input VSWR	input frequency ≤ 4 GHz > 4 GHz to ≤ 16 GHz	1.25 (meas.) 1.4 (meas.)

<sup>&</sup>lt;sup>5</sup> The RF characteristics are measured for an R&S®RTP164 oscilloscope with 16 GHz bandwidth at zero offset.

### **Waveform measurements**

General features	measurement panels	up to 8 measurement panels; each panel may contain any number of automatic
	gate	measurements of the same category delimits the display region evaluated for
	reference levels	automatic measurements user-configurable vertical levels define support structures for automatic
	statistics	measurements displays maximum, minimum, mean, standard deviation, RMS and measurement count for each automatic
	track	measurement measurement results displayed as continuous trace that is time-correlated to
	long-term analysis	the measurement source history of selected measurements as
	histogram	trace against count index available for the main measurement of
		each measurement panel; automatic or manual selection of bin number and scale; counters for measurements under, within
	limit check	and over the histogram range  measurements tested against user- defined margins and limits; pass or fail conditions may launch automatic response: acquisition stop, beep, print and save waveform
Measurement category	amplitude and time	amplitude, high, low, maximum, minimum, peak-to-peak, mean, RMS, sigma, overshoot, area, rise time, fall time, positive width, negative width, period, frequency, duty cycle, delay, phase, burst width, pulse count, positive switching, negative switching, cycle area, cycle mean, cycle RMS, cycle sigma, setup/hold time, setup/hold ratio, pulse train, slew rate rising, slew rate falling, DC voltmeter (requires Rohde & Schwarz active probe with R&S®ProbeMeter functionality)
	eye diagram	extinction ratio, eye height, eye width, eye top, eye base, Q factor, S/N ratio, duty cycle distortion, eye rise time, eye fall time, eye bit rate, eye amplitude, jitter (peak-to-peak, 6-sigma, RMS)
	spectrum	channel power, bandwidth, occupied bandwidth, harmonic search, total harmonic distortion THD in dB and % using power values, total harmonic distortion variants THD <sub>a</sub> , THD <sub>u</sub> and THD <sub>r</sub> using voltage, overall voltage and overall voltage root means square, peak list (THD <sub>a</sub> , THD <sub>u</sub> , THD <sub>r</sub> and peak list require R&S®RTP-K37 option)
	jitter	cycle-to-cycle jitter, N-cycle jitter, cycle-to-cycle width, cycle-to-cycle duty cycle, time-interval error, data rate, unit interval, skew delay, skew phase; requires R&S®RTP-K12 option

Cursors	setup	up to 4 cursor sets on screen, each set consisting of two horizontal and two vertical cursors
	target	acquired waveforms (input channels), math waveforms, reference waveforms, track waveforms, XY diagrams
	operating mode	vertical measurements, horizontal measurements or both; vertical cursors either set manually or locked to waveform
Histogram	source	acquired waveform (input channels), math waveform, reference waveform
	mode	vertical (for timing statistics), horizontal (for amplitude statistics)
	automatic measurements	waveform count, waveform samples, histogram samples, histogram peak, peak value, maximum, minimum, median, range, mean, sigma, mean ± 1, 2 and 3 sigma, marker ± probability

### Mask testing

Test definition	number of masks	up to 8 simultaneously
	source	acquired waveforms (input channels), math waveforms
	fail condition	sample hit or waveform hit
	fail tolerance	minimum number of fail events for test fail in range from 0 to 4 000 000 000
	test rate	up to 600 000 waveforms/s
	action on error	acquisition stop, beep, print and save waveform
	save/load to file	test and mask settings (.xml format)
Mask definition with segments	number of independent segments	up to 8
-	segment definition	array of points and connecting rule (upper, lower, inner) define segment region
	segment input	point and click on touchscreen, editable list
Mask definition with tolerance tube	input signal	acquired waveform
	definition of tolerance tube	horizontal width, vertical width, vertical stretch, vertical position
Mask definition with eye mask assistant	primary mask shape	
(requires R&S®RTP-K12 option)	type	diamond, square, hexagon, octagon
, ,	dimensions	main and secondary height, main and secondary width, depending on selected shape
	position	vertical offset, horizontal offset
	secondary mask shapes	
	locations	any combination of left, right, top, bottom
	position	horizontal and vertical offset with respect to center of primary mask shape
Result statistics	category	completed acquisitions, remaining acquisitions, state, sample hits, mask hits, fail rate, test result (pass or fail)
Visualization options	waveform style	vectors, dots
	violation highlighting	hits (on/off), highlight persistence (50 ms to 50 s or infinite), waveform color (default: red)
	mask colors	configurable colors for mask without violation (default: translucent gray), mask with violation (default: translucent red), mask with contact (default: translucent pale red)

### **Waveform math**

General features	number of math waveforms	up to 4		
	number of reference waveforms	up to 4		
	waveform arithmetic	user-selectable average or envelope of		
		consecutive waveforms		
Algebraic expressions	user may define complex mathematical e	xpressions involving waveforms and		
	measurement results	measurement results		
	math functions	add, subtract, multiply, divide, absolute		
		value, square, square root, integrate,		
		differentiate, exp, log <sub>10</sub> , log <sub>e</sub> , log <sub>2</sub> , rescale,		
		sin, cos, tan, arcsin, arccos, arctan, sinh,		
		cosh, tanh, autocorrelation,		
		crosscorrelation		
	logical operators	not, and, nand, or, nor, xor, nxor		
	relational operators	Boolean result of =, $\neq$ , >, <, $\leq$ , $\geq$		
	frequency domain	spectral magnitude and phase, real and		
		imaginary spectra, group delay		
	digital filter	lowpass, highpass		
	special functions	CDR transform; requires R&S®RTP-K12		
		option		
Optimized math	operators	add, subtract, multiply, invert, absolute		
		value, differentiate, log <sub>10</sub> , log <sub>e</sub> , log <sub>2</sub> ,		
		rescale, FIR, FFT magnitude		
Spectrum analysis	FFT magnitude spectrum			
	setup parameters	center frequency, frequency span, frame		
		overlap, frame window (rectangular,		
		Hamming, Hann, Blackman, Gaussian,		
		Flattop, Kaiser Bessel), user-selectable		
		spectrum averaging, RMS, envelope,		
		max. hold and min. hold (max. hold and		
		min. hold require R&S®RTP-K37 option)		
	max. realtime waveform acquisition	> 1 000 waveforms/s		
	rate			

## Search and mark function

General description	scans acquired waveforms for oc highlights each occurrence	scans acquired waveforms for occurrence of a user-defined set of events and highlights each occurrence	
Basic setup	source	all physical input channels, math waveforms, reference waveforms	
	search panels	up to 8, where each panel may manage multiple event searches	
	search mode	manually triggered or continuous	
	search conditions	search conditions	
	supported events	edge, glitch, width, runt, window, timeout,	
		interval, slew rate, data2clock, state	
	event configuration	identical to corresponding trigger event	
	event selection	single or multiple events on same source	
Search scope	mode	current waveform, gated time interval	
Result visualization	table	table	
	sort mode	horizontal position or vertical value	
	max. result count	specifies max. table size	
	zoom window	centered on highlighted event	

# **Display characteristics**

Diagram types	Yt, XY, spectrum, long-term measurement, spectrogram (spectrogram requires R&S®RTP-K37 option)	
Horizontal divisions	10	
Vertical divisions	10	
Display interface configuration	display area can be split up into separate diagram areas by dragging and dropping signal icons;	
	each diagram area can hold any number of signals;	
	diagram areas may be stacked on top of each other and later accessed via the	
	dynamic tab menu	
Signal bar	accommodates timebase settings, trigger settings and signal icons;	
	signal bar may be docked to left or right side of display area or hidden	
Signal icon	each active waveform is represented by a separate signal icon on the signal bar; the	
	signal icon displays the individual vertical and acquisition settings; a waveform can be	
	minimized to its signal icon so that it appears as a realtime preview in miniature form;	
	dialog boxes and measurement results may also be minimized to a signal icon	
Axis label	X-axis ticks and Y-axis ticks labeled with tick value and physical unit	
Diagram label	diagrams may be individually labeled with a descriptive user-defined name	
Diagram layout	grid, crosshair, axis labels and diagram label may be switched on and off separately	
Persistence	50 ms to 50 s, or infinite	
Zoom	user-defined zoom window provides vertical and horizontal zoom;	
	each diagram area supports multiple zoom windows;	
	touchscreen interface simplifies resize and drag operations on zoom window	
Signal colors	predefined or user-defined color tables for persistence display	

## Input and output

Front		
Channel inputs		BNC-compatible,
		for details see Vertical system
	probe interface	auto-detection of passive probes,
		Rohde & Schwarz active probe interface
External trigger input		BNC,
		for details see Trigger system
	probe interface	auto-detection of passive probes,
		Rohde & Schwarz active probe interface
Probe compensation output	signal shape	rectangle, $V_{low} = 0 \text{ V}$ , $V_{high} = 1 \text{ V}$
		amplitude 1 V (V <sub>pp</sub> ) ± 5 %
	frequency	1 kHz ± 1 %
	impedance	50 Ω (nom.)
Ground jack		4 mm, connected to ground
USB interface		2 ports, type A plug, version 3.1 gen 1
Option slots		2

#### Version 14.00, December 2021

Rear		
Trigger out		BNC,
		for details see Trigger system
USB interface		2 ports, type A plug version 3.1 gen 1
		2 ports, type A plug version 2.0
		1 port, type B plug, version 3.1 gen 1
LAN interface		RJ-45 connector,
		supports 10/100/1000BASE-T
External monitor interface		DVI-D and display port,
		output of scope display or extended
		desktop display
GPIB interface	function	interface in line with IEC 625-2
		(IEEE 488.2)
	command set	SCPI 1999.0
	connector	IEEE-488 24-pin Amphenol female
	interface functions	SH1, AH1, T6, L4, SR1, RL1, PP1, DC1,
		DT1, C0
External reference input	connector	BNC female
	impedance	50 Ω (nom.)
	input frequency range	1 MHz to 20 MHz, in 1 MHz steps
	sensitivity	$\geq$ 0 dBm into 50 $\Omega$
Reference output 10 MHz	connector	BNC female
	impedance	50 Ω (nom.)
	level	> 7 dBm
Auxiliary output		SMA connector, for future use
Digital data interface 40G		QSFP+ connector, for future use
Option slots		2
Security slot		for standard Kensington style lock

## **General data**

type	12.1" LC TFT color display with capacitive
	touchscreen
resolution	1280 × 800 pixel (WXGA)
	Windows 10 64-bit
operating temperature range	+5 °C to +45 °C
	-40 °C to +70 °C
otorago tomporataro rango	in line with MIL-PRF-28800F section
	4.5.5.1.1.1 class 3 for operation
	+25° C/+40 °C at 85 % rel. humidity
	cyclic, in line with IEC 60068-2-30
	+30 °C/+40 °C/+45 °C at 95/75/45 %,
	in line with MIL-PRF-28800F section
	4.5.5.1.1.2 class 3 for operation
	up to 3000 m above sea level
	up to 15000 m above sea level
	up to 15000 iii above sea level
sinusoidal	5 Hz to 150 Hz, max. 1.8 g at 55 Hz,
	0.5 g from 55 Hz to 150 Hz,
	in line with EN 60068-2-6
random	10 Hz to 300 Hz,
	acceleration 1.2 g (RMS),
	in line with EN 60068-2-64
	40 g shock spectrum,
	in line with MIL-STD-810E, method
	no. 516.4, procedure I
	in line with CISPR 11/EN 55011 group 1
	class A (for a shielded test setup);
	the instrument complies with the emission
	requirements stipulated by EN 55011,
	EN 61326-1 and EN 61326-2-1 class A,
	making the instrument suitable for use in
	industrial environments
	in line with IEC/EN 61326-1 table 2,
	immunity test requirements for industrial
	environment <sup>6</sup>
	VDE-GS, <sub>C</sub> CSA <sub>US</sub> , KC
	, , , , , , , , , , , , , , , , , , , ,
	1 year
	100 V to 240 V at 50 Hz to 60 Hz,
	100 V to 130 V at 400 Hz,
	max. 13 A to 4.7 A,
	in line with MIL-PRF 28800F section 3.5
	max. 1000 W
	in line with IEC 61010-1, EN 61010-1,
	CAN/CSA-C22.2 No. 61010-1-12,
	UL 61010-1
	operating temperature range storage temperature range

<sup>&</sup>lt;sup>6</sup> Test criterion is displayed noise level within ±1 div for input sensitivity of 5 mV/div.

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Mechanical data		
Dimensions (W × H × D)	with R&S®RTP-B20 handles	463 mm × 285 mm × 349 mm
		$(18.23 \text{ in} \times 11.22 \text{ in} \times 13.74 \text{ in})$
	with shock protection	441 mm × 285 mm × 316 mm
	·	$(17.36 \text{ in} \times 11.22 \text{ in} \times 12.44 \text{ in})$
Weight	without options, nominal	18.0 kg (39.68 lb)

# **Options**

## R&S®RTP-B1 mixed signal option

Mixed signal option, additional 16 logic channels

#### Vertical system

Input channels		16 logic channels (D0 to D15)
Arrangement of input channels		arranged in two logic probes with
		8 channels each, assignment of the logic
		probes to the channels (D0 to D7 or
		D8 to D15) is displayed on the probe
DC input resistance	at probe tips	100 kΩ ± 2 % (meas.)
Input capacitance		4 pF (meas.)
Maximum input frequency	signal with minimum input voltage swing	400 MHz (meas.)
	and hysteresis setting: normal	
Maximum input voltage		±40 V (V <sub>p</sub> )
Minimum input voltage swing		500 mV (V <sub>pp</sub> ) (meas.)
Threshold groups		D0 to D3, D4 to D7, D8 to D11 and
		D12 to D15
Threshold level	range	±8 V in 25 mV steps
	predefined	CMOS 5.0 V, CMOS 3.3 V, CMOS 2.5 V,
		TTL, ECL, PECL, LVPECL
Threshold accuracy	threshold setting between ±4 V	±(100 mV + 3 % of threshold setting)
		(meas.)
Comparator hysteresis		normal, robust, maximum

#### **Horizontal system**

Channel deskew	range for each channel	±200 ns
Channel-to-channel skew		< 500 ps (meas.)

#### **Acquisition system**

Sampling rate	max.	5 Gsample/s on each channel
Realtime waveform acquisition rate	max.	> 200 000 waveforms/s
Memory depth	at max. sampling rates	200 Msample for every channel
	at lower sampling rates	100 Msample for every channel
Decimation		pulses lost due to decimation are
		displayed

#### Trigger system

Holdoff range	time	100 ns to 10 s, fixed and random
	events	1 event to 2 000 000 000 events

Trigger modes			
Edge	triggers on specified slope (pos	triggers on specified slope (positive, negative or either) in the source signal	
	sources	any channel from D0 to D15 or any logical	
		combination of D0 to D15	
Width	triggers on positive or negative	e pulse of specified width in the source signal; width can	
	be shorter, longer, equal, insid	e or outside the interval	
	sources	any channel from D0 to D15 or any logical	
		combination of D0 to D15	
	pulse width	200 ps to 10 s	
Timeout	triggers when the source signa	triggers when the source signal stays high, low or unchanged for a specified period of	
	time		
	sources	any channel from D0 to D15 or any logical	
		combination of D0 to D15	
	timeout	200 ps to 10 s	
Data2clock	triggers on setup time and hold	d time violations between a clock signal and a data	
	signal; monitored time interval	signal; monitored time interval with a max. width of 200 ns and a position of	
	max. ±1 μs relative to the clock	max. ±1 μs relative to the clock edge	
	data signal	any subset of channels from D0 to D15 or	
		any user-defined bus signal	
	clock signal	any channel from D0 to D15	

Pattern	triggers when the source goes tregual, inside or outside a specifi	rue or stays true for a period of time shorter, longer, ed range	
	sources	any logical combination of D0 to D15 or any user-defined bus signal	
	pulse width	200 ps to 10 s	
State	triggers on the slope (positive, n matches a user-defined logical s	triggers on the slope (positive, negative or either) of the clock signal when data signal	
	data signal	any logical combination of D0 to D15 or	
		any user-defined bus signal	
	clock signal	any channel from D0 to D15	
Serial pattern		of up to 32 bit; pattern bits may be high (H), low (L) or may be positive, negative or either	
	data signal	any channel from D0 to D15 or any logical combination of D15 to D15	
	clock signal	any channel from D0 to D15	
	max. data rate	1 Gbps	
Serial bus trigger	optional	dedicated software options	
	sources	any channel from D0 to D15	

#### **Waveform measurements**

General features	measurement panels, gate, statistics,
	long-term analysis and limit check; see
	features of the base unit
Measurement sources	all channels from D0 to D15 or any logical
	combination of D0 to D15
Automatic measurements	positive pulse width, negative pulse width,
	period, frequency, burst width, delay,
	phase, positive duty cycle, negative duty
	cycle, positive pulse count, negative pulse
	count, rising edge count, falling edge
	count
Additional cursor function	display of decoded bus value at the cursor
	position

#### Waveform math

Function	any logical combination of D0 to D15
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#### Search and mark functions

The search function will be available in a future software release.

#### **Display characteristics**

Display of logical channels		selectable size and position on screen, diagram configuration by dragging and dropping signal icons
Bus decode	number of bus signals	4
	bus types	unclocked and clocked
	display types	decoded bus, logical signal, bus + logical signal, amplitude signal, amplitude + logical signal, tabulated list (decoded time interval selected with cursors)
	position and size	size and position on screen selectable
	data format of decoded bus	hex, unsigned integer, signed integer, fractional, binary
	data format of amplitude signal	unsigned integer, signed integer, fractional, binary offset
Channel activity display		independent of the scope acquisition, the state (stays low, stays high or toggles) of the channels from D0 to D15 is displayed
		the channels from D0 to D15 is in the signal icon

### R&S®RTP-B6 arbitrary waveform generator

Arbitrary function/waveform generator, 2 analog channels, 8-bit pattern generator

#### Analog channels

General	
Output channel	2 channels
Vertical resolution	14 bit
Operating modes	function generator, arbitrary waveform
	generator, modulation, frequency sweep

Function generator	output of predefined waveforms	output of predefined waveforms		
Sample rate	·	500 Msample/s		
Waveforms		sine, square/pulse, ramp, DC, noise, sine cardinal (sinc), Gaussian pulse, Lorentz, exponential fall, exponential rise, cardiac		
Sine	frequency range	1 mHz to 100 MHz		
	amplitude flatness (relative to 1 kHz)	1 7 0		
	f ≤ 100 kHz	≤ ±0.1 dB		
	100 kHz < f ≤ 60 MHz	≤ ±0.3 dB		
	60 MHz < f ≤ 100 MHz	≤ ±0.5 dB		
	total harmonic distortion (1 V (Vpp) into 5	0 Ω)		
	f ≤ 100 kHz	≤ -70 dBc (= THD ≤ 0.032 %)		
	100 kHz < f ≤ 15 MHz	≤ –55 dBc		
	15 MHz < f ≤ 35 MHz	≤ -40 dBc		
	35 MHz < f ≤ 100 MHz	≤ -30 dBc		
	nonharmonic spurious (1 V ( $V_{pp}$ ) into 50 $\Omega$ )	-65 dBc (meas.)		
	phase noise (meas.)			
	f ≤ 25 MHz	≤ -105 dBc (1 Hz) at 1 kHz offset,		
		≤ -115 dBc (1 Hz) at 10 kHz offset,		
		≤ -125 dBc (1 Hz) at 100 kHz offset		
	25 MHz < f ≤ 100 MHz	≤ -105 dBc (1 Hz) at 1 kHz offset,		
		≤ -110 dBc (1 Hz) at 10 kHz offset,		
		≤ -115 dBc (1 Hz) at 100 kHz offset		
Square/pulse	frequency range	1 mHz to 30 MHz		
	duty cycle (if pulse width limit is not exceeded)	0.01 % to 99.99 %, 0.01 % resolution		
	pulse width	≥ 16.5 ns, 0.1 ns resolution		
	rise/fall time			
	f ≤ 10 Hz	90 μs (meas.)		
	10 Hz < f ≤ 30 MHz	9 ns (meas.)		
	overshoot	≤ 2 %		
	jitter (cycle-to-cycle)	≤ 40 ps (RMS) (meas.)		
Ramp (triangle, sawtooth)	frequency range	1 mHz to 1 MHz		
,	linearity	≤ 0.1 % (meas.)		
	variable symmetry	0 % to 100 %, 0.1 % resolution		
DC	level range	•		
	into 50 Ω	± [ 3 V – (noise amplitude [V <sub>pp</sub> ] / 2) ]		
	into open circuit	± [ 6 V – (noise amplitude [V <sub>pp</sub> ] / 2) ]		
Noise	amplitude			
	DC	0 V to 6 V (V <sub>pp</sub> ) (into 50 Ω)		
		0 V to 12 V (V <sub>pp</sub> ) (into open circuit),		
		4 digits resolution		
	all other waveforms	0 % to 100 % of AC signal amplitude,		
		1 % resolution		
	bandwidth	≥ 100 MHz		
Sine cardinal (sinc)	frequency range	1 mHz to 2 MHz		
Gaussian pulse	frequency range	1 mHz to 10 MHz		
Lorentz	frequency range	1 mHz to 5 MHz		
Exponential rise/fall	frequency range	1 mHz to 1 MHz		
Cardiac	frequency range	1 mHz to 1 MHz		

Arbitrary waveform generator	output of user-defined waveforms	
Waveform length		1 sample to 40 Msample on each channel
Sample rate		1 sample/s to 250 Msample/s
Filter bandwidth		100 MHz

Modulation		
Sample rate		500 Msample/s
Modulation types		amplitude modulation (AM), frequency modulation (FM), frequency-shift key modulation (FSK), pulse width modulation (PWM)
Carrier waveform	AM, FM, FSK	sine
	PWM	square/pulse
AM	modulation signals	sine, square, ramp (triangle, sawtooth)
	modulation frequency	1 mHz to 1 MHz
	depth	0 % to 100 %, 0.1 % resolution
FM	modulation signals	sine, square, triangle, ramp, inverse ramp
	modulation frequency	1 mHz to 1 MHz
	frequency deviation	1 mHz to 10 MHz
FSK	modulation signal	50 % duty cycle square wave
	range of frequency 1, frequency 2	1 mHz to 100 MHz
	hop rate	1 mHz to 1 MHz
PWM	modulation signals	sine, square, ramp
	depth	0 % to 99.99 % of the duty cycle,
		0.01 % resolution

Frequency sweep	output of a sinusoidal waveform with the frequency changing linearly between the start frequency and the stop frequency within the sweep time	
	sample rate	500 Msample/s
	waveform	sine
	frequency range	1 mHz to 100 MHz
	direction	up (start frequency < stop frequency)
		down (start frequency > stop frequency)
	sweep time	1 ms to 500 s

Two-channel operation	operating modes	independent channels, coupled
		parameters, differential
	parameter coupling	none, frequency and/or amplitude
	relative phase	-180° to 180°, 0.1° resolution
	channel-to-channel skew	≤ 200 ps (meas.)
	channel-to-channel isolation	
	(each channel with same output amplitude)	
	f ≤ 10 MHz	≥ 60 dB (meas.)
	10 MHz < f ≤ 100 MHz	≥ 40 dB (meas.)

Outputs			
Connectors		BNC female on the rear panel	
Function		on, off, inverted	
Output impedance		50 Ω (nom.)	
Overload protection		a short-circuit to ground is tolerated indefinitely, automatic shutoff in case of voltages ≥ +7 V or ≤ -7 V (meas.),	
		automatic shutoff in case of overcurrent, max. –20 V to +20 V without damage (meas.), ESD protection	
Amplitude range 7	sine, square/pulse, ramp, pulse	, exponential rise, exponential fall	
	into 50 Ω	10 mV to 6 V ( $V_{pp}$ ) (frequency $\leq$ 50 MHz), 10 mV to 4 V ( $V_{pp}$ ) (frequency $>$ 50 MHz)	
	into open circuit	20 mV to 12 V (V <sub>pp</sub> ) (frequency ≤ 50 MHz), 20 mV to 8 V (V <sub>pp</sub> ) (frequency > 50 MHz)	
	sine cardinal (sinc)	( )	
	into 50 Ω	10 mV to 3 V (V <sub>pp</sub> )	
	into open circuit	20 mV to 6 V (V <sub>DD</sub> )	
	Gauss, Lorentz	_ с зо о т ( трру	
	into 50 Ω	10 mV to 2.5 V (V <sub>pp</sub> )	
	into open circuit	20 mV to 5 V (V <sub>pp</sub> )	
	arbitrary waveforms	20 πν το σ ν (νρρ)	
	into 50 Ω	10 mV to 6 V ( $V_{pp}$ ) (sample rate $\leq$ 125 Msample/s), 10 mV to 4 V ( $V_{pp}$ )	
	into open circuit	(sample rate > 125 Msample/s) 20 mV to 12 V ( $V_{pp}$ ) (sample rate $\leq$ 125 Msample/s), 20 mV to 8 V ( $V_{pp}$ ) (sample rate > 125 Msample/s)	
	resolution	1 mV	
	accuracy	± [1% of control + 1 mV (V <sub>pp</sub> )] at 1 kHz	
DC offset range		, exponential rise, exponential fall	
· · · - · · · · · · · · · · · · · ·	into 50 $\Omega$	$\pm [3 \text{ V} - (\text{amplitude } [\text{V} (\text{V}_{pp})] / 2)]$	
	into open circuit	$\pm [6 \text{ V} - (\text{amplitude } [\text{V} (\text{V}_{pp})] / 2)]$ $\pm [6 \text{ V} - (\text{amplitude } [\text{V} (\text{V}_{pp})] / 2)]$	
	sine cardinal (sinc), Gauss, Lore		
	into 50 $\Omega$	±0.5 V	
	into open circuit	±0.5 V	
	resolution	1 mV	
	accuracy	± (2 % of control + 2 mV)	
Frequency accuracy	accuracy	$ \Delta f  \le [\text{(timebase accuracy)} \times (\text{nominal})$	
Trequency accuracy		frequency) + 1 µHz ] (timebase accuracy: see Horizontal	
		system)	

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 $<sup>^{7}\,\,</sup>$  Amplitude is the sum of the AC amplitude and the noise amplitude.

#### 8-bit pattern generator

Function	output of user-defined patterns
Output channels	8 channels, coupled w.r.t. pattern length
	and data output rate
Pattern length	1 bit to 40 Mbit on each channel
Bit rate	1 bit/s to 40 Mbit/s

Outputs		
Connector		16-pin double row connector, 2.54 mm
		pitch, located on an adapter board, which
		is connected via a removable ribbon cable to the R&S®RTP-B6
Output impedance		330 Ω (nom.)
Overload protection	reverse input voltage without damage	-0.5 V to +6.5 V (meas.), ESD protection
Amplitude	low level output voltage (I = 100 μA)	
	output voltage	0 V + 0.15 V/- 0.02 V
	accuracy	≤ 0.15 V (meas.)
	high level output voltage	
	setting range	1.2 V to 5.0 V
	resolution	0.1 V
	accuracy	≤ 0.05 V
Rise/fall time		8 ns (meas.)
Overshoot		≤ 5 % (meas.)

## R&S®RTP-B7 16 GHz differential pulse source

16 GHz differential pulse source with reference output

### Output 8

Output pulse		two complementary negative going square wave pulse train signals, single-ended or differential operation, fast transition on rising and falling edge, adjustable amplitude and timing parameters, free-running or phase-locked to base unit
Outputs	single-ended operation	single-ended output (OutP)
		single-ended reference output (RefP)
	differential operation	differential output (OutP, OutN)
		differential reference output (RefP, RefN)
Output connectors		SMA female connectors
Reverse DC voltage		0 V
Output impedance	single-ended outputs	50 Ω (nom.)
	both differential pairs	100 Ω (nom.)
Return loss	≤ 10 GHz	> 15 dB (meas.)
	≤ 20 GHz	> 12 dB (meas.)

### DC characteristics 8

Output high level		0 V ± 10 mV
Output low level		–200 mV to –50 mV
setting range		adjustable in 10 mV steps
Output low level error	OutP	±2 % of setting ±15 mV
Output low level imbalance	between OutP and RefP, OutN, RefN	±1 dB (meas.)

 $<sup>^{8}</sup>$   $\,$  All four outputs terminated with 50  $\Omega;$  all parameters are measured at all four single-ended outputs, unless noted.

#### Time domain characteristics 8

Transition time	10 % to 90 %, rising and falling edge, calculated from 0.36/bandwidth	
	output low level: -120 mV to -50 mV	20 ps
	output low level: -200 mV to -130 mV	22 ps
Step response aberrations	for the first 100 ps after step transition	±10 % (meas.)
	for the first 1 ns after step transition	±4 % (meas.)
	until 100 ps before following step transition	±2 % (meas.)
Repetition rate	low frequency mode	5 Hz, 10 Hz, 20 Hz, 50 Hz, 100 Hz, 200 Hz, 500 Hz to 1 MHz
	high frequency mode, phase-locked to base unit	5 MHz, 10 MHz, 25 MHz, 50 MHz, 100 MHz, 250 MHz
	high frequency mode, free-running	5 MHz, 10 MHz, 25 MHz, 50 MHz
Positive duty cycle	measured at 50 % of transition	
	low frequency mode	10 % to 90 %, adjustable in 10 % steps
	high frequency mode	50 %
Duty cycle error	measured at 50 % of transition, at OutP and RefP outputs	
	low frequency mode	±2 % (meas.)
	high frequency mode	±0.1 % (meas.)
Skew	measured at 50 % of transition, between OutP and OutN output	< 0.5 ps (meas.)
Clock accuracy	free-running	±100 ppm (meas.)
•	phase-locked to base unit	see Timebase accuracy of base unit

### Frequency domain characteristics 8

Analog bandwidth (-3 dB)	output low level: -120 mV to -50 mV	> 18 GHz (meas.)
	output low level: -200 mV to -130 mV	> 16.5 GHz (meas.)
Spectral magnitude error to ideal step	≤ 5 GHz	+0.5 dB to -1 dB (meas.)
spectrum	≤ 12 GHz	+0.5 dB to -2 dB (meas.)
	≤ analog bandwidth	+0.0 dB to -3 dB (meas.)

# R&S®RTP-B21 adapter rear option slot

General description	The R&S®RTP-B21 adapter is necessary to use the R&S®RTP-B1 or the
	R&S®RTP-B1E option at the rear side of the instrument. For mounting instructions,
	please see R&S®RTP user manual.

# R&S®RTP-K1 I<sup>2</sup>C/SPI serial triggering and decoding

I <sup>2</sup> C triggering and decoding		
Protocol configuration	bit rate	auto-detected
	auto threshold setup	assisted threshold configuration for I <sup>2</sup> C triggering and decoding
	device list	associate frame address with symbolic ID
Trigger	source (clock and data)	any input channel or logical channel
	bit rate	up to 6.5 Mbps
	trigger event setup	start, stop, restart, missing ACK, address, data, address + data
	address setup	7 bit or 10 bit address (value in hex, decimal, octal or binary); ACK, NACK or either; read, write or either; R/W bit included in address value or apart; condition =, ≠, ≥, ≤, in range, out of range
	data setup	data pattern up to 8 byte (hex, decimal, octal or binary); condition $=$ , $\neq$ , $\geq$ , $\leq$ , in range, out of range; offset within frame in range from 0 byte to 4095 byte
Decode	source (clock and data)	any input channel, math waveform, reference waveform, logical channel
	display type	decoded bus, logical signal, bus + logical signal, tabulated list, decode layers
	color coding	frame, start/restart, address, R/W bit, data. ACK/NACK, stop, error
	address and data format	hex, decimal, octal, binary, ASCII; symbolic names for user-defined subset of addresses
	decode layer	off, edges, bits
Search	search event setup	combination of start, stop, restart, missing ACK, address, data, address + data
	event settings	same as trigger event settings

SPI triggering and decoding		
Protocol configuration	type	2-wire, 3-wire and 4-wire SPI
	bit rate	auto-detected
	bit order	LSB first, MSB first
	word size	4 bit to 32 bit
	frame condition	SS, timeout
	polarity (MOSI, MISO, SS, CLK)	active high, active low
	phase (CLK)	first edge, second edge
	auto threshold setup	assisted threshold configuration for SPI triggering and decoding
Trigger	source (MOSI, MISO, SS, CLK)	any input channel or logical channel
	bit rate	up to 50 Mbps
	trigger event setup	start of frame, MOSI, MISO, MOSI + MISO
	data setup	data pattern up to 256 bit (hex or binary);
		condition =, ≠; offset within frame in range from 0 bit to 32767 bit
Decode	source (MOSI, MISO, SS, CLK)	any input channel, math waveform, reference waveform, logical channel
	display type	decoded bus, logical signal, bus + logical signal, tabulated list, decode layers
	color coding	frame, word, error
	data format	hex, decimal, octal, binary, ASCII
	decode layer	edges, bits, words
Search	search event setup	start of frame, MOSI, MISO, MOSI + MISO
	event settings	same as trigger event settings

# R&S®RTP-K2 UART/RS-232/RS-422/RS-485 serial triggering and decoding

Protocol configuration	bit rate	300 bps to 20 Mbps
Ç	signal polarity	idle low, idle high
	number of bits	5 bit to 9 bit
	bit order	LSB first, MSB first
	parity	odd, even, mark, space, none
	stop bit	1, 1.5 or 2 bit periods
	end of packet	word, timeout, none
	auto threshold setup	assisted threshold configuration for
		UART triggering and decoding
Trigger	source (TX and RX)	any input channel or logical channel
	trigger event setup	start bit, packet start, data, parity error,
		break condition
	data setup	data pattern up to 256 bit (hex, decimal,
		octal, binary or ASCII); condition =, ≠;
		offset within packet in range 0 bit to
		32767 bit
Decode	source (TX and RX)	any input channel, math waveform,
		reference waveform, logical channel
	display type	decoded bus, logical signal, bus + logical
		signal, tabulated list
	color coding	packet, data payload, start error, parity
		error, stop error
	data format	hex, decimal, octal, binary, ASCII

# R&S®RTP-K3 CAN/LIN serial triggering and decoding

CAN triggering and decoding		
Protocol configuration	signal type	CAN_H, CAN_L
	bit rate	100 bps to 1 Mbps
	sampling point	5 % to 95 % within bit period
	device list	associate frame identifier with symbolic ID, load DBC file content
	auto threshold setup	assisted threshold configuration for CAN triggering and decoding
Trigger	source	any input channel or logical channel
	trigger event setup	start of frame, frame type, identifier, identifier + data, symbolic, error condition (any combination of CRC error, bit stuffing error, form error and ACK error)
	identifier setup	frame type (data, remote or both), identifier type (standard or extended); condition =, ≠, ≥, ≤, in range, out of range
	data setup	data pattern up to 8 byte (hex, decimal, octal or binary); big-endian or little-endian; condition $=$ , $\neq$ , $\geq$ , in range, out of range
	symbolic setup	message name, signal name; numeric signal condition =, $\neq$ , $\geq$ , $\leq$ , in range, out of range; enumerated signal condition =, $\neq$ , $\geq$ , $\leq$
Decode	source	any input channel, math waveform, reference waveform, logical channel
	display type	decoded bus, logical signal, bus + logical signal, tabulated list
	color coding	start of frame, identifier, DLC, data payload, CRC, end of frame, error frame, overload frame, CRC error, bit stuffing error
	data format	hex, decimal, octal, binary, ASCII, symbolic
Search	source	any input channel or logical channel
	search event setup	combination of start of frame, frame type, identifier, identifier + data, error condition (any combination of CRC error, bit stuffing error, form error and ACK error) or only symbolic
	event settings	same as trigger event settings

LIN triggering and decoding Protocol configuration	version	1.3, 2.x or SAE J602; mixed traffic is
1 Totoooi oomigaration	Version	supported
	bit rate	standard bit rate (1.2/2.4/4.8/9.6/10.417/ 19.2 kbps) or user-defined bit rate in range from 1 kbps to 20 kbps
	device list	associate frame identifier with symbolic ID, data length and protocol version
	auto threshold setup	assisted threshold configuration for LIN triggering and decoding
Trigger	source	any input channel
	trigger event setup	start of frame (sync break), identifier, identifier + data, wake-up frame, error condition (any combination of checksum error, parity error and sync field error)
	identifier setup	range from 0d to 63d; select condition =, ≠, ≥, ≤, in range, out of range for trigger "identifier"; select single identifier and condition = for trigger "identifier + data"
	data setup	data pattern up to 8 byte (hex, decimal, octal or binary); condition =, $\neq$ , $\geq$ , $\leq$ , in range, out of range
Decode	source (TX and RX)	any input channel, math waveform, reference waveform
	display type	decoded bus, logical signal, bus + logical signal, tabulated list
	color coding	frame, frame identifier, data payload, checksum, error condition
	data format	hex, decimal, octal, binary, ASCII
Search	search event setup	combination of start of frame (sync break), identifier, identifier + data, wake-up frame, error condition (any combination of checksum error, parity error and sync field error)
	event settings	same as trigger event settings

## R&S®RTP-K6 MIL-STD-1553 serial triggering and decoding

		_
Protocol configuration	signal type	single-ended
	bit rate	standard bit rate (1 Mbit/s)
	polarity	normal, inverted
	device list	associate frame identifier with symbolic ID
	auto threshold setup	assisted threshold configuration
	timing	min. gap (2 μs to 262 μs) or off;
		max. response (2 µs to 262 µs) or off
Trigger	trigger event setup	sync, word, data word, command/status word, command word, status word, error condition
	sync and word setup	all words, command/status word, data word
	data word setup	RTA (condition =, $\neq$ , $\geq$ , $\leq$ , in range, out of range); data pattern (condition =, $\neq$ , $\geq$ , $\leq$ , in range, out of range); payload data index (=, $<$ , $>$ , $\geq$ , $\leq$ , range); max. length of data pattern is 4 byte
	command/status word setup	RTA (condition =, $\neq$ , $\geq$ , $\leq$ , in range, out of range); 11 bit pattern (condition =, $\neq$ , $\geq$ , $\leq$ , in range, out of range)
	command word setup	RTA (condition =, $\neq$ , $\geq$ , $\leq$ , in range, out of range); subaddress/mode (condition =, $\neq$ , $\geq$ , $\leq$ , in range, out of range); data word count/mode count (condition =, $\neq$ , $\geq$ , $\leq$ , in range, out of range); direction (T/R)
	status word	RTA (condition =, ≠, ≥, ≤, in range, out of range); status flags (message error, instrumentation, service request, broadcast command, busy, subsystem flag, dynamic bus control, terminal flag)
	error condition	any combination of sync error, Manchester error, parity error, timing error (see protocol configuration)
Decode	source	any analog input channel, math waveform, reference waveform
	display type	decoded bus, logical signal, bus + logical signal, tabulated list
	color coding	frame (word), sync, RTA, status bit field, parity, data field, error condition
	data format	hex, octal, binary, ASCII, signed, unsigned
Search	search event setup	sync, word, data word, command/status word, command word, status word, error condition
	event settings	same as trigger event settings

## R&S®RTP-K7 ARINC 429 serial triggering and decoding

Protocol configuration	signal type	single-ended
	bit rate	high (100 kbit/s)
		low (12 kbit/s to 14.5 kbit/s)
	polarity	A leg, B leg
	device list	associate frame identifier with symbolic ID
	auto threshold setup	assisted threshold configuration
	timing	min. gap (0 bit to 100 bit) or off; max. gap (0 bit to 1000 bit) or off
Trigger	trigger event setup	word start, word stop, label + data, error condition
	label + data setup	label (condition =, $\neq$ , $\geq$ , $\leq$ , in range, out of range); data (condition =, $\neq$ , $\geq$ , $\leq$ , in range, out of range); SDI/SSM
	error condition	any combination of coding error, parity error, timing error (see protocol configuration)
Decode	source	any analog input channel, math waveform, reference waveform
	display type	decoded bus, logical signal, bus + logical signal, tabulated list
	color coding	frame (word), label, SDI, data, SSM, parity, error condition
	data format	hex, octal, binary, ASCII, signed, unsigned
Search	search event setup	word start, word stop, label + data, error condition
	event settings	same as trigger event settings

# $R\&S^{@}RTP\text{-K8}$ Ethernet (10BASE-T/100BASE-TX) serial triggering and decoding

Protocol configuration	signal type	one channel, differential
	bit rate	selectable/adjustable
	auto threshold setup	assisted threshold configuration
	full autoset	adjust horizontal and vertical resolution
		and perform auto threshold
	source (SDATA)	analog and math channels
	variants	10BASE-T, 100BASE-TX
Trigger	frame start	trigger at start of any MAC frame
	pattern	fast trigger for 10BASE-T MAC frames,
		32 bytes, index 0 to 65535
	frame	advanced trigger configuration for MAC
		frames only;
		48 bit destination address, 48 bit source
		address, 16 bit length/type, 32 bit frame
		check; conditions =, $\neq$ , <, $\leq$ , >, $\geq$ , in range,
		out of range
	error	preamble error, length error, CRC error
Decode	display type	decoded bus, logical signal, bus + logical
		signal, tabulated list, details, decode
		layers
	color coding	preamble, frame, destination address,
		source address, data
	data format	hex, octal, binary, signed, unsigned
	decode layer	edges, binary
	result export	export of all result data into CSV, XML,
		HTM and PY file formats
Search	search event setup	frame, error
	event settings	same as trigger event settings

# R&S®RTP-K9 CAN-FD serial triggering and decoding

Protocol configuration	signal type	CAN_H, CAN_L
	standard	ISO, non-ISO (Bosch)
	bit rate	
	arbitration rate	10 kbps to 1 Mbps
	data rate	10 kbps to 15 Mbps
	sampling point	5 % to 95 % within bit period; independent
		settings for arbitration phase and data
		phase
	device list	associate frame identifier with symbolic
		ID, load DBC file content
	auto threshold setup	assisted threshold configuration
Trigger	source	any input channel or logical channel
	trigger event setup	start of frame, frame type, identifier,
		identifier + data, symbolic, error condition
		(any combination of CRC error, bit stuffing
		error, form error and ACK error)
	identifier setup	frame type (data, remote or both),
		identifier type (standard or extended);
		condition =, $\neq$ , $\geq$ , $\leq$ , in range, out of range
	FD bits	FDF, BRS and ESI (0, 1, X)
	data setup	data pattern up to 8 byte in the complete
		data range (hex, decimal, octal or binary);
		condition =, $\neq$ , $\geq$ , $\leq$ , in range, out of range
	symbolic setup	message name, signal name;
		numeric signal condition =, ≠, ≥, ≤, in
		range, out of range;
		enumerated signal condition =, ≠, ≥, ≤
Decode	source	any input channel, math waveform,
		reference waveform, logical channel
	display type	decoded bus, logical signal, bus + logical
		signal, tabulated list
	color coding	start of frame, identifier, FD bits, DLC,
		data payload, CRC, end of frame, error
		frame, overload frame, CRC error, bit
		stuffing error
	data format	hex, decimal, octal, binary, ASCII,
	arrangement of the leavestic	symbolic
Caarah	supported data length	64
Search	source	any input channel or logical channel
	search event setup	combination of start of frame, frame type,
		identifier, identifier + data, error condition
		(any combination of CRC error, bit stuffing
		error, form error and ACK error) or only
	ovent settings	symbolic
	event settings	same as trigger event settings

### R&S®RTP-K11 I/Q software interface

General	function		mixing, filtering, decim	ation and recording of RF or
			baseband signals as I/	9
	input signals		four real RF signals or	
			two complex I/Q signals or	
			two real RF signals an	
			one complex I/Q signal	
	mixer frequency		between 100 Hz and 2	
	mixer frequency		deactivated)	o onz (or mixer
	sampling rate of record	ded I/Q samples	selectable	and 20 Gsample/s user-
	digital filter bandwidth	(flat frequency response)	4 % to 80 % of samplir	ng rate
	recording length		max. 40 Msample with	four input signals 9
Trigger	mode		auto or normal	
	operation		triggers on acquired si	gnal after A/D conversion
	'		serial bus and MSO tri	
Display			magnitude of the down	
Amplitude flatness with	R&S®RTP044	max. used center	with I/Q bandwidth	with I/Q bandwidth
RF signal input (meas.)	1100 1111 044	frequency	100 MHz	500 MHz
Tti signai input (incus.)		≤ 100 MHz	±0.10 dB	000 1111 12
		≤ 500 MHz	±0.2 dB	+0.2 dB
				±0.2 dB
		≤ 1 GHz	±0.2 dB	±0.3 dB
		≤ 2 GHz	±0.2 dB	±0.3 dB
	D000DTD001	≤ 4 GHz	±0.4dB	±1.8 dB
	R&S®RTP064	max. used center	with I/Q bandwidth	with I/Q bandwidth
		frequency	100 MHz	500 MHz
		≤ 100 MHz	±0.10 dB	
		≤ 500 MHz	±0.2 dB	±0.2 dB
		≤ 1 GHz	±0.2 dB	±0.3 dB
		≤ 2 GHz	±0.2 dB	±0.3 dB
		≤ 4 GHz	±0.3 dB	±0.3 dB
		≤ 6 GHz	±0.5 dB	±2.0 dB
	R&S®RTP084	max. used center	with I/Q bandwidth	with I/Q bandwidth
		frequency	100 MHz	500 MHz
		≤ 100 MHz	±0.10 dB	
		≤ 500 MHz	±0.2 dB	±0.2 dB
		≤ 1 GHz	±0.2 dB	±0.3 dB
		≤ 4 GHz	±0.3 dB	±0.3 dB
		≤ 8 GHz	±0.5 dB	±2.0 dB
	R&S®RTP134	max. used center	with I/Q bandwidth	with I/Q bandwidth
	NOO NIF 104			
		frequency	100 MHz	500 MHz
		≤ 100 MHz	±0.10 dB	10.2 dP
		≤ 500 MHz	±0.2 dB	±0.2 dB
		≤ 1 GHz	±0.2 dB	±0.3 dB
		≤ 4 GHz	±0.3 dB	±0.3 dB
		≤ 8 GHz	±0.5 dB	±2.0 dB
	R&S®RTP164	max. used center	with I/Q bandwidth	with I/Q bandwidth
		frequency	100 MHz	500 MHz
		≤ 100 MHz	±0.10 dB	
		≤ 500 MHz	±0.2 dB	±0.2 dB
		≤ 1 GHz	±0.2 dB	±0.3 dB
		≤ 4 GHz	±0.3 dB	±0.3 dB
		≤ 8 GHz	±0.5 dB	±2.0 dB

9 Maximum recording length of 25 Msample for sampling rates of recorded I/Q samples 250 Msample/s to 400 Msample/s.

# R&S®RTP-K12 jitter analysis

General description	The R&S®RTP-K12 jitter analysis option extends the functionality of the standard R&S®RTP firmware with a suite of measurement, analysis and visualization tools for		
	signal integrity analysis and jitter c		
Waveform measurements	category	jitter	
	measurement functions	cycle-to-cycle jitter, N-cycle jitter, cycle-to	
		cycle width, cycle-to-cycle duty cycle,	
		time-interval error, data rate, unit interval,	
		skew delay, skew phase; the standard	
		time measurements period, frequency an	
		setup/hold are also available in the jitter	
		category for convenience	
	track	measurement results displayed as	
		continuous trace that is time-correlated to	
		the measurement source; applicable to	
		time measurements from categories "jitte	
		and "amplitude and time"; track trace may	
		be used as source for cursor	
		measurements, automatic measurements	
		math waveforms and reference waveform	
Waveform math	FFT on track	FFT spectrum of the track trace of	
		measurement results	
	CDR transform	recovers clock timing from source	
		waveform with software CDR and	
		generates synthetic clock waveform that i	
		time-correlated to source	
Software clock data recovery (CDR)	number of CDR instances	up to 2; independently configurable	
	algorithm	phase-locked loop (PLL), constant	
		frequency	
	configuration	nominal bit rate, PLL order (first or	
		second), PLL loop bandwidth, PLL	
		damping factor, initial phase alignment,	
		result selection during initial	
		synchronization	
Mask testing with eye mask assistant	primary mask shape		
	type	diamond, square, hexagon, octagon	
	dimensions	main and secondary height, main and	
		secondary width, depending on selected	
		shape	
	position	vertical offset, horizontal offset	
	secondary mask shapes		
	locations	any combination of left, right, top, bottom	
	position	horizontal and vertical offset with respect	
		to center of primary mask shape	

## R&S®RTP-K19 zone trigger

General description	The R&S®RTP-K19 zone trigger enables the triggering on user-defined zones dr the display.	
Source		acquired waveforms (input channels), math waveforms
Zone definition	number of zones	up to 8
	shapes	rectangles, polygones
	types	must intersect, must not intersect
	combination of zones	logical combination of zones of multiple sources using Boolean expressions
Trigger compatibility		compatible with the trigger modes edge, glitch, width, runt, window, timeout, interval, slew rate, data2clock, pattern, state, serial pattern, trigger qualification, and sequence trigger

### R&S®RTP-K21 USB 2.0 compliance test

The option is used in combination with the free-of-charge R&S®ScopeSuite PC software, which can be downloaded from the Rohde & Schwarz website. R&S®RTP-K21 performs USB 2.0 compliance test measurements with R&S®ScopeSuite, including tests for USB 2.0 (high speed), USB 1.1 (full speed) and USB 1.0 (low speed) with the R&S®RTP. R&S®ScopeSuite supports the R&S®RT-ZF1 USB 2.0 compliance test fixture set and the Allion USB test fixture solutions and the USB-IF signal quality board device/host; R&S®ScopeSuite supports Windows 7, 8 and 10.

Supported USB 2.0 complian		
USB device test	high speed	signal quality (EL_2, 4, 5, 6, 7); packet parameters (EL_21, 22, 25); chirp timing (EL_28, 29, 31); suspend/resume/reset timing (EL_27, 28, 38, 39, 40); test J/K, SE0_NAK (EL_8, 9); receiver sensitivity (EL_16, 17, 18)
	full speed and low speed	full speed signal quality; back voltage; inrush current
USB host test	high speed	signal quality (EL_2, 3, 6, 7); packet parameters (EL_21, 22, 23, 25, 55); chirp timing (EL_33, 34, 35); suspend/resume/reset timing (EL_39, 41); test J/K, SE0_NAK (EL_8, 9)
	full speed and low speed	low speed signal quality downstream; full speed signal quality downstream; drop; droop
USB hub test	high speed	signal quality upstream (EL_2, 4, 6, 7); signal quality downstream (EL_2, 3, 6, 7); jitter downstream (EL_47); packet parameters upstream (EL_21, 22, 25); hub receiver sensitivity upstream (EL_16, 17, 18); repeater downstream (EL_42, 43, 44, 45, 48); repeater upstream (EL_42, 43, 44, 45); chirp timing upstream (EL_28, 29, 31); suspend/resume/reset timing upstream (EL_27, 28, 38, 39, 40); test J/K, SE0_NAK downstream (EL_8, 9); test J/K, SE0_NAK downstream (EL_8, 9)
	full speed and low speed	low speed signal quality downstream; full speed signal quality upstream; full speed signal quality downstream; inrush current upstream; drop downstream; droop downstream; back voltage

### R&S®RTP-K22 Ethernet compliance test (10/100/1000BASE-T/EEE)

The option is used in combination with the free-of-charge R&S®ScopeSuite PC software, which can be downloaded from the Rohde & Schwarz website. R&S®RTP-K22 performs Ethernet compliance test measurements with R&S®ScopeSuite, including tests for 10BASE-T, 100BASE-TX,1000BASE-T and energy efficient Ethernet (EEE) with the R&S®RTP. R&S®ScopeSuite supports the R&S®RT-ZF2 Ethernet compliance test fixture set as well as the R&S®RT-ZF4 and R&S®RT-ZF5 for EEE; R&S®ScopeSuite supports Windows 7, 8 and 10.

Supported Ethernet complian	nce tests	
Standard reference		IEEE 802.3-2012
1000BASE-T	with/without disturber	with/without TX_CLK transmitter
		distortion (40.6.1.2.4)
		peak differential output voltage
		(40.6.1.2.1)
		maximum output droop (40.6.1.2.2)
	''I TV 0117	differential output templates (40.6.1.2.3)
	with TX_CLK	jitter master mode (40.6.1.2.5),
		jitter slave mode (40.6.1.2.5)
	without TX_CLK	jitter master mode (40.6.1.2.5)
	common	MDI return loss (40.8.3.1),
		common mode output voltage (40.8.3.3)
100BASE-TX		amplitude domain tests
		(9.1.2.2, 9.1.3 and 9.1.4)
		rise and fall times (9.1.6)
		peak to peak duty cycle distortion (9.1.8)
		peak to peak transmitter jitter (9.1.9)
		active output interface template (annex J)
		transmitter return loss (9.1.5)
		receiver return loss (9.2.2)
10BASE-T	no TPM	link test pulse template (14.3.1.2.1)
		TP_IDL template (14.3.1.2.1)
		peak differential voltage (14.3.1.2.1)
		harmonic content (14.3.1.2.1)
		output timing jitter (14.3.1.2.3)
	with TPM	link test pulse template (14.3.1.2.1)
		TP_IDL template (14.3.1.2.1)
		MAU template (14.3.1.2.1)
		output timing jitter (14.3.1.2.3)
	common	transmitter return loss (14.3.1.2.2),
		receiver return loss (14.3.1.3.4)
		common mode output voltage
		(14.3.1.2.5)

Supported EEE compliance tests	
Standard reference	IEEE 802.3-2012
1000BASE-T EEE	quiet time (78.2)
(requires R&S®RT-ZF5)	refresh time (master) (78.2)
	refresh time (slave) (78.2)
	wake state levels (40.6.1.2.7)
	transmitter timing jitter with TX_TCLK (master) (40.6.1.2.5)
	transmitter timing jitter with TX_TCLK (slave) (40.6.1.2.5)
	transmitter timing jitter without TX_TCLK (master) (40.6.1.2.5)
	transmitter timing jitter without TX_TCLK (master) (40.6.1.2.5)
100BASE-TX EEE (requires R&S®RT-ZF5)	sleep time (24.2.3.4 and 78.2)
	LPI quiet time (24.2.3.4 and 78.2)
	LPI refresh time (24.2.3.4 and 78.2)
	LPI transmitter timing jitter (24.2.3.4 and 78.2)
	transmit wake time (24.2.3.4 and 78.2)

10BASE-Te	no TPM	link test pulse template (14.3.1.2.1)
(requires R&S®RT-ZF4)		TP_IDL template (14.3.1.2.1)
		peak differential voltage (14.3.1.2.1)
		harmonic content (14.3.1.2.1)
		output timing jitter (14.3.1.2.3)
	with TPM	link test pulse template (14.3.1.2.1)
		TP_IDL template (14.3.1.2.1)
		MAU template (14.3.1.2.1)
		output timing jitter (14.3.1.2.3)
	common	transmitter return loss (14.3.1.2.2),
		receiver return loss (14.3.1.3.4)
		common mode output voltage
		(14.3.1.2.5)

### R&S®RTP-K23 Ethernet compliance test (2.5/5/10GBASE-T)

The option is used in combination with the free-of-charge R&S®ScopeSuite PC software, which can be downloaded from the Rohde & Schwarz website. R&S®RTP-K23 performs Ethernet compliance test measurements with the R&S®ScopeSuite, including tests for 2.5GBASE-T, 5GBASE-T and 10GBASE-T with the R&S®RTP. R&S®ScopeSuite supports the R&S®RT-ZF2 Ethernet compliance test fixture set; R&S®ScopeSuite supports Windows 7, 8 and 10.

Supported Ethernet compliance tests	
Standard reference	IEEE 802.3-2012 and IEEE P802.3bz
2.5/5GBASE-T	maximum output droop (126.5.3.1)
	transmitter nonlinear distortion
	(126.5.3.2)
	transmitter timing jitter master mode and
	clock frequency (126.5.3.3 and 126.5.3.5)
	transmitter timing jitter slave mode
	(126.5.3.3)
	transmitter power spectral density and
	power level (126.5.3.4)
	MDI return loss (126.6.2.1)
10GBASE-T	maximum output droop (55.5.3.1)
	transmitter linearity (55.5.3.2)
	transmitter timing jitter master mode
	(55.5.3.3)
	transmitter timing jitter slave mode
	(55.5.3.3)
	transmitter power spectral density
	(55.5.3.4)
	transmitter power level (55.5.3.4)
	transmitter clock frequency (55.5.3.5)
	MDI return loss (55.8.2.1)

# R&S®RTP-K24 Ethernet compliance test (100BASE-T1)

The option is used in combination with the free-of-charge R&S®ScopeSuite PC software, which can be downloaded from the Rohde & Schwarz website. R&S®RTP-K24 performs 100BASE-T1 compliance test measurements with R&S®ScopeSuite. R&S®ScopeSuite supports the R&S®RT-ZF2, R&S®RT-ZF7A and R&S®RT-ZF8 Ethernet compliance test fixtures. The chapters after the test cases refer to IEEE 802.3-2018 and OPEN Alliance ECU specification version 2.0.

Supported Ethernet compliance tests	
00BASE-T1	transmitter output droop (96.5.4.1)
	transmitter distortion with and without
	disturber (96.5.4.2)
	transmitter timing jitter master mode
	(96.5.4.3)
	transmitter timing jitter slave mode
	(96.5.4.3)
	transmitter power spectral density
	(96.5.4.4)
	transmitter clock frequency (96.5.4.5)
	transmitter peak differential output
	(96.5.6)
	MDI return loss (96.7.1.3)
	MDI mode conversion loss (96.8.2.2)
	MDI mode conversion loss adapter
	verification (96.8.2.2)
	MDI common mode emission (96.5.1.

# R&S®RTP-K26 MIPI D-PHY compliance test

The option is used in combination with the free-of-charge R&S®ScopeSuite PC software, which can be downloaded from the Rohde & Schwarz website. R&S®RTP-K26 performs D-PHY compliance test measurements with R&S®ScopeSuite. R&S®ScopeSuite supports Windows 7, 8 and 10. The numbers behind the test refer to the MIPI CTS for D-PHY V1.1 and V1.2.

upported D-PHY compliance PHY	group 1 (7 tests): data lane LP-TX	data lane LP-TX Thevenin output high
	signaling requirements	level voltage (V <sub>OH</sub> ) – 1.1.1
		data lane LP-TX Thevenin output low
		level voltage (V <sub>OL</sub> ) – 1.1.2
		data lane LP-TX from 15 % to
		85 % rise time (T <sub>RLP</sub> ) – 1.1.3
		data lane LP-TX from 85 % to
		15 % fall time (T <sub>FLP</sub> ) – 1.1.4
		data lane LP-TX slew rate versus C <sub>LOAD</sub>
		$(\delta V/\delta t_{SR}) - 1.1.5$
		data lane LP-TX pulse width of
		exclusive-OR clock (T <sub>LP-PULSE-TX</sub> ) – 1.1.6
		data lane LP-TX period of exclusive-OR
		clock (T <sub>LP-PER-TX</sub> ) – 1.1.7
	group 2 (5 tests): clock lane LP-TX	clock lane LP-TX Thevenin output high
	signaling requirements	level voltage (V <sub>OH</sub> ) – 1.2.1
	olgitaling requirements	clock lane LP-TX Thevenin output low
		level voltage (V <sub>OL</sub> ) – 1.2.2
		clock lane LP-TX from 15 % to
		85 % rise time (T <sub>RLP</sub> ) – 1.2.3
		clock lane LP-TX from 85 % to
		15 % fall time (T <sub>FLP</sub> ) – 1.2.4
		clock lane LP-TX slew rate versus C <sub>LOA</sub>
		$(\delta V/\delta t_{SR}) - 1.2.5$
	group 2 (16 toota): data lana US TV	
	group 3 (16 tests): data lane HS-TX signaling requirements	data lane HS entry: data lane T <sub>LPX</sub> value 1.3.1
		data lane HS entry: data lane
		T <sub>HS-PREPARE</sub> value – 1.3.2
		data lane HS entry: data lane
		T <sub>HS-PREPARE</sub> + T <sub>HS-ZERO</sub> value – 1.3.3
		data lane HS-TX differential voltages
		$V_{OD(0)}$ and $V_{OD(1)} - 1.3.4$
		data lane HS-TX differential voltage
		mismatch ΔV <sub>OD</sub> – 1.3.5
		data lane HS-TX single-ended output
		voltages V <sub>OHHS(DP)</sub> and V <sub>OHHS(DN)</sub> – 1.3.6
		data lane HS-TX static common mode
		voltages V <sub>CMTX(1)</sub> and V <sub>CMTX(0)</sub> – 1.3.7
		data lane HS-TX static common mode
		voltage mismatch ΔV <sub>CMTX(1.0)</sub> – 1.3.8
		data lane HS-TX dynamic common-leve
		variations from 50 MHz to 450 MHz
		$\Delta V_{CMTX(LF)} - 1.3.9$
		data lane HS-TX dynamic common-leve
		variations above 450 MHz ΔV <sub>CMTX(HF)</sub> –
		1.3.10
		data lane HS-TX from 20 % to 80 % rise
		time $t_R - 1.3.11$
		data lane HS-TX from 80 % to 20 % fall
		time $t_F - 1.3.12$
		data lane HS exit: T <sub>HS-TRAIL</sub> value – 1.3.1
		data lane HS exit: from 30 % to 85 %
		post-EoT rise time T <sub>REOT</sub> – 1.3.14
		data lane HS exit: T <sub>EOT</sub> value – 1.3.15
		data lancino cata regi value – 1.3.13

D-PHY	group 4 (18 tests): clock lane HS-TX	clock lane HS entry: T <sub>LPX</sub> value – 1.4.1
	signaling requirements	clock lane HS entry: T <sub>CLK-PREPARE</sub> value –
	orginaling requirements	1.4.2
		clock lane HS entry:
		T <sub>CLK-PREPARE</sub> + T <sub>CLK-ZERO</sub> value – 1.4.3
		clock lane HS-TX differential voltages
		$V_{OD(0)}$ and $V_{OD(1)} - 1.4.4$
		clock lane HS-TX differential voltage
		mismatch $\Delta V_{OD} - 1.4.5$
		clock lane HS-TX single-ended output
		voltages V <sub>OHHS(DP)</sub> and V <sub>OHHS(DN)</sub> – 1.4.6
		clock lane HS-TX static common mode
		voltages V <sub>CMTX(1)</sub> and V <sub>CMTX(0)</sub> – 1.4.7
		clock lane HS-TX static common mode
		voltage mismatch ΔV <sub>CMTX(1, 0)</sub> – 1.4.8
		clock lane HS-TX dynamic common-level
		variations from 50 MHz to 450 MHz
		$\Delta V_{CMTX(LF)} - 1.4.9$
		clock lane HS-TX dynamic common-level
		variations above 450 MHz ΔV <sub>CMTX(HF)</sub> –
		1.4.10
		clock lane HS-TX from 20 % to 80 % rise
		time t <sub>R</sub> – 1.4.11
		clock lane HS-TX from 80 % to 20 % fall
		time t <sub>F</sub> – 1.4.12
		clock lane HS exit: T <sub>CLK-TRAIL</sub> value -
		1.4.13
		clock lane HS exit: from 30 % to 85 %
		post-EoT rise time T <sub>REOT</sub> – 1.4.14
		clock lane HS exit: T <sub>EOT</sub> value – 1.4.15
		clock lane HS exit: T <sub>HS-EXIT</sub> value – 1.4.16
		clock lane HS clock instantaneous: UI <sub>INST</sub>
		value – 1.4.17
		clock lane HS clock delta UI:
		(ΔUI) value – 1.4.18
	group 5 (6 tests): HS-TX clock-to-data	HS entry: T <sub>CLK-PRE</sub> value – 1.5.1
	lane timing requirements	HS exit: T <sub>CLK-POST</sub> value – 1.5.2
		HS clock rising edge alignment to first
		payload bit – 1.5.3
		data-to-clock skew (T <sub>SKEW[TX]</sub> ) – 1.5.4
		initial HS skew calibration burst
		T <sub>SKEWCAL-SYNC</sub> T <sub>SKEWCAL</sub> — 1.5.5
		periodic HS skew calibration burst
		T <sub>SKEWCAL-SYNC</sub> T <sub>SKEWCAL</sub> - 1.5.6

# R&S®RTP-K35 bus analysis

General description	The R&S®RTP-K35 bus analysis option adds bus measurements and analysis functions for dedicated protocols.		
	supported protocol options	R&S®RTP-K1 (I <sup>2</sup> C, SPI), R&S®RTP-K2 (UART), R&S®RTP-K3 (CAN, LIN), R&S®RTP-K8 (Ethernet), R&S®RTP-K9 (CAN-FD), R&S®RTP-K40 (RFFE), R&S®RTP-K57 (100BASE-T1)	
Measurements	field value	allows the selection of frame types and displays the value of a specified field; the value can be displayed as track and histogram.	
	frame to frame	measures the distance between the starts of two selectable frame types in seconds;	
	trigger to frame	measures the distance between the trigger event and the start of a selectable frame type in seconds; alternatively, measures the distance between the start of a selectable frame type and the trigger event	
	frame count	counts the total number of frames in each acquisition	
	gap time	measures the distance between the end of a selectable frame type to the start of another selectable frame type in seconds	
	bus idle ratio	measures the percentage of idle time on a bus; idle time is defined as the time where the bus is not occupied by frames	
	main bit rate	measures the main bit rate of a protocol based on the relevant bits in a frame; if a protocol provides multiple bit rates, the most relevant bit rate is being measured	
	secondary bit rate	for protocols with multiple bit rates, the secondary bit rate is available	
	frame error count	counts the total number of erroneous frames in each acquisition	
	frame error rate	measures the percentage of erroneous frames in relation to the total frames	
	consecutive frame error rate	measures the percentage of follow up (consecutive) frame errors, ignoring all single frame errors	

# R&S®RTP-K37 spectrogram

General description	The R&S®RTP-K37 spectrogram option allows advanced signal analysis in the		
	frequency domain.		
Spectrogram	display characteristics	spectrogram display; a separate spectrogram can be created for each FFT display; each FFT segment of a captured acquisition is displayed in a separate spectrogram line support of logarithmic frequency x-axis	
	number of spectrograms	up to 4	
	signal colors	predefined or user-defined color tables for persistence display with the spectrogram	
	time lines	in stop mode two separate time lines can be used to navigate through a spectrogram in time; for each time line the relevant FFT segment is displayed in a diagram; the difference in acquisition time between the timelines is displayed	
Logarithmic frequency x-axis	display characteristics	logarithmic frequency x-axis for the FFT display with support of analysis tools like cursors and masks	
		logarithmic frequency x-axis for the spectrogram display	
Waveform measurements	measurement functions	total harmonic distortion variants THDa, THDa and THDr using voltage, overall voltage and overall voltage root means square	
	peak list	peak list; diagram labels for easy identification of the peak list entries in the diagram	
Waveform math		user-selectable max. hold and min. hold in addition to spectrum averaging, RMS and envelope	

# R&S®RTP-K40 MIPI RFFE serial triggering and decoding

Protocol configuration	signal type	two channel, single-ended
	bit rate	auto-detected
	auto threshold setup	assisted threshold configuration
	full autoset	full autoset of horizontal and vertical settings and auto threshold setup
	source (SCLK, SDATA)	any two input channels, math waveforms, reference waveforms, or logical channels
	supported version	1.X, 2.0, 2.1 and 3.0
	read mode	standard or sRead mode
	glitch filter	configurable glitch filter
	gap detection	detect gaps between sequences
Trigger	trigger event setup	sequence start, sequence stop, register 0
990.	sequence start setup	write, register write, register read, extended register write, extended register read, extended register write long, extended register read long, error condition types  4 bit slave address; conditions =, ≠, <, ≤, >, ≥, in range, out of
		range
	sequence stop setup	4 bit slave address; conditions =, ≠, <, ≤, >, ≥, in range, out of range
	register 0 write setup	4 bit slave address, 7 bit data word; conditions =, ≠, <, ≤, >, ≥, in range, out of range for each of these options
	register write/read	4 bit slave address, 5 bit register address, 8 bit data word; conditions =, ≠, <, ≤, >, ≥, in range, out of range for each of these options
	extended register write/read	4 bit slave address; 8 bit address,
		byte count: 0 to 15 (inclusive), data pattern: 1 to 16 bytes (hex or binary); conditions =, $\neq$ , <, $\leq$ , >, $\geq$ , in range, out of range for each of these options; index: 1 to 16 selects the specific data frame byte; conditions =, $\neq$ , <, $\leq$ , >, $\geq$ , in range
	extended register write long/read long	4 bit slave address, 8 bit address, byte count: 0 to 7 (inclusive), data pattern: 0 to 8 bytes (hex or binary); conditions =, ≠, <, ≤, >, ≥, in range, out of range for each of these options; index: 1 to 8 selects the specific data frame byte; conditions =, ≠, <, ≤, >, ≥, in range
	interrupt summary and notification	4 bit slave address, bit count 0 to 32, notification and interrupt bits
	masked write	4 bit slave address; 8 bit address, 8 bit mask, 8 bit data pattern; conditions =, ≠, <, ≤, >, ≥, in range, out of range for each of these options; frame byte; conditions =, ≠, <, ≤, >, ≥,
	master ownership handover	in range  2 bit MID; conditions =, ≠, <, ≤, >, ≥, in range, out of range for each of these options;
		frame byte; conditions =, $\neq$ , <, $\leq$ , >, $\geq$ , in range
	master write/read	2 bit MID, 8 bit address, 16 bit data pattern; conditions =, ≠, <, ≤, >, ≥, in range, out of range for each of these options;
		frame byte; conditions =, $\neq$ , <, $\leq$ , >, $\geq$ , in range

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	master context transfer write/read	2 bit MID, 8 bit byte count, 8 bit address, data pattern: 1 to 8 bytes (hex or binary); conditions =, $\neq$ , <, $\leq$ , >, $\geq$ , in range, out of range for each of these options; index: 1 to 256 selects the specific data frame byte; conditions =, $\neq$ , <, $\leq$ , >, $\geq$ , in range
	error condition	SSC error; length error, bus park error, parity error, no response, unknown sequence, version error, min. gap between frames: 1 ns to 10 us
Decode	display type	decoded bus, logical signal, bus + logical signal, tabulated list, decode layers
	color coding	sequence, frame, error
	data format	hex, octal, binary, signed, unsigned
	decode layer	off, edges, bits
Search	search event setup	sequence start, sequence stop, register 0 write, register write, register read, extended register write, extended register read, extended register write long, extended register read long, master read, master write, master ownership handover, interrupt summary and notification, error condition types
	event settings	same as trigger event settings

# R&S®RTP-K42 MIPI D-PHY serial triggering and decoding

Protocol configuration	signal type	clock, data (differential or single-ended)
	bit rate	selectable without clock lane (1 Mbps to
		2.5 Gbps),
		auto detect with clock lane
	source	any input channels, math waveforms,
		reference waveforms
	variants	D-PHY v. 1.2, CSI-2 v.1.2, DSI v. 1.3
Trigger	trigger event setup	HS start of packet
		HS end of packet
		HS packet header
		HS data
		LP escape mode
		LP lane turnaround
		LP HS request
	HS packet header setup	virtual channel, data type, word count;
	- F	conditions =, $\neq$ , <, $\leq$ , >, $\geq$ , in range, out of
		range for data and word count
	HS data	virtual channel, data type, word count,
		data value, data index; conditions =, ≠, <,
		≤, >, ≥, in range, out of range for data
		count, word count, data value
	LP escape mode	escape mode, data value, data index;
		conditions =, $\neq$ , <, $\leq$ , >, $\geq$ , in range, out of
		range for escape mode and data value
Decode	display type	decoded bus, tabulated list, details,
		decode layers
	color coding	high speed: frames according to trace,
	ů – i	cells;
		low power: escape word, data word
	data format	hex, octal, binary, , signed, unsigned
	decode layer	off, HS edges, HS binary, HS burst bits,
	•	HS burst bytes, HS merged bytes, HS
		merged words, LP edges, LP states, LP
		active states, LP binary
	result export	export of all result data into CSV. XIVIL.
	result export	export of all result data into CSV, XML, HTM and PY file formats
Search	·	HTM and PY file formats
Search	search event setup	HTM and PY file formats HS start of packet
Search	·	HTM and PY file formats HS start of packet HS end of packet
Search	·	HTM and PY file formats  HS start of packet  HS end of packet  HS packet header
Search	·	HTM and PY file formats HS start of packet HS end of packet HS packet header HS data
Search	·	HTM and PY file formats  HS start of packet  HS end of packet  HS packet header  HS data  LP escape mode
Search	·	HTM and PY file formats HS start of packet HS end of packet HS packet header HS data

# R&S®RTP-K44 MIPI M-PHY serial triggering and decoding

Protocol configuration	signal type	up to 4 channels,
1 Totocor configuration	signal type	differential
	bit rate	clock recovery
	source (SDATA)	analog and math channels,
	,	reference waveforms
	variants	UniPro 1.6 and M-PHY 4.0
Trigger	trigger event setup	M-PHY burst
		M-PHY adapt
		M-PHY LCC
		UniPro DL_PDU frames
		UniPro PACP frames
		UniPro trigger upper frames
		M-PHY/UniPro errors
Decode	display type	decoded bus, logical signal, bus + logical
		signal, tabulated list, details, decode
		layers
	color coding	for different cells/frame types
	data format	K/D symbols; with UniPro additionally:
		hex, octal, binary, signed, unsigned
	decode layer	off, edges, bits, 8b/10b synbols, LCC bits;
		with UniPro additionally: filter/descrambler,
		lane merge, bytes
Search	search event setup	M-PHY burst
		M-PHY adapt
		M-PHY LCC
		UniPro DL_PDU frames
		UniPro PACP frames
		UniPro trigger upper frames
		M-PHY/UniPro errors

# R&S®RTP-K50 Manchester and NRZ serial triggering and decoding

Protocol configuration	signal type	selectable,
		one channel, differential or single-ended,
		two channel, differential or single-ended
	bit rate	auto detected, adjustable
	auto threshold setup	assisted threshold configuration
	source	analog, math. channels, logical (only NRZ)
	bit encoding variants	Manchester,
		Manchester II,
		NRZ clocked,
		NRZ unclocked
	properties	active state (high/low), idle state
		(high/low), clock edge (first/second)
	frame separation	gap, enable signal (only NRZ)
Frame format	frame	multiple frame management,
		frame identification and sync,
		variable length frames,
		variable number of cells
	cells	name, size (bits), numeric format,
		bit order, color
	file storage of frame format	save/load as xml files
Trigger	variants	all supported bit encodings
	trigger event setup	frame start, pattern, advanced trigger
	frame start	gap, start bit
	pattern	up to 256 bit pattern within 65 535 bit
	·	frame
	advanced trigger	frame type (with OR combinations), frame
		fields (with AND combinations), frame field
		data; conditions =, $\neq$ , <, $\leq$ , >, $\geq$ , in range,
		out of range for data count, word count,
		data value; error types
Decode	display type	decoded bus, logical signal, bus signal,
		tabulated list, result details, decode layers
	color coding	according to cell configuration table
	data format	according to cell configuration table
	decode layer	edges, binary
Search	event settings	same as advanced trigger settings
Filter	<u> </u>	ode events that shall be shown in the result table.
	Events that do not match the criteria set will not be displayed in the table when the filter	
	is turned on.	
	settings	same as advanced trigger settings

### R&S®RTP-K52 8b10b serial triggering and decoding

Protocol configuration	signal type	one/two channel, differential, single-ended
	bit rate	selectable/adjustable auto configuration,
		ideal for bitrate up to 6.25 Gbit/s
	auto threshold setup	assisted threshold configuration
	one click setup	convenient way for perfect decode results;
		auto scaling of waveforms, auto threshold
		and bitrate estimation on one click
	source (differential, single-ended D+/D-)	full combination of either analog, math, reference channels
	variants	all layer 1 (physical layer) encoded 8b/10b protocols, recommended for Ethernet, FibreChannel 1G, 2G, PCI Express, Serial ATA, Serial Rapid IO (SRIO), XAUI
Trigger	trigger event setup	symbols, errors
55	symbols	K/D symbol (8 bit/10 bit), complex expression (combination of K/D symbols, wildcards, disparity)
	errors	disparity, glitching and unknown symbol
Decode	display type	decoded bus, bus signal, tabulated list, details, decode layers
	color coding	sync symbol, K symbols, data (Dx.y) coding and error coding
	data format	hex, 10 bit and K/D representation
	decode layer	edges, bits
Search	search event setup	symbols, errors
	event settings	same as trigger event settings

### R&S®RTP-K55 MDIO serial triggering and decoding

Protocol configuration	bit rate	up to 5 Mbps (auto-detected)
	auto threshold setup	assisted threshold configuration for
		MDIO triggering and decoding
	device list	associate frame address with symbolic ID
Trigger	source (clock and data)	any input channel or logical channel
	trigger event setup	start, stop, ST, OP, PHY address, register address, data
	ST setup	01 (clause 22), 00 clause 45, any
	OP setup	address, write, post read, read, any
	PHY address setup	5 bit address (hex, decimal, octal or binary); equal
	PHY register (clause 22)/device type (clause 45) setup	5 bit value (hex, decimal, octal or binary); equal
	data (clause 22)/data/address (clause 45)	16 bit value (hex, decimal, octal or binary); equal
Decode	source (clock and data)	any input channel, math waveform, reference waveform, logical channel
	display type	decoded bus, logical signal, bus + logical signal, tabulated list, decode layers
	color coding	frame, PHY address, PHY register, address, data, turnaround
	PHYAD/PRTAD	symbolic names for user defined addresses
	address/data field format	hex, decimal, octal, binary, ASCII, signed, unsigned
	decode layer	final, edges, binary
Search	source (clock and data)	any input channel, math waveform, reference waveform, logical channel
	search event setup	start, stop, ST, OP, PHY address, register address, data
	event settings	same as trigger event settings

# R&S®RTP-K57 Ethernet (100BASE-T1) serial triggering and decoding

Protocol configuration	signal type	one channel differential, two channels single-ended, optional additional use of
		reverse channels for signal improvement:
		one channel differential, two channels
		single-ended
	symbol rate	66.667 Msymbol/s, adjustable for testing
	thresholds	upper/lower, assisted threshold
		configuration
	source	any analog input channels, math waveforms, reference waveforms
	polarity	normal, inverted
	mode	slave, master
Trigger	trigger event setup	frame start,
		MAC frame,
		idle frame,
		error conditions
	MAC frame setup	destination address (condition =, ≠, <, >,
	,	≥, ≤, in range, out of range), source
		address (condition =, $\neq$ , <, >, $\geq$ , $\leq$ , in
		range, out of range), length/type
		(condition =, $\neq$ , <, >, $\geq$ , $\leq$ , in range, out of
		range), frame check (condition =, $\neq$ , <, >,
		≥, ≤, in range, out of range), data
		(condition =, $\neq$ , <, >, $\geq$ , $\leq$ , in range, out of
		range), data index (condition =, $<$ , $>$ , $\ge$ , $\le$ ,
		range)
	error condition setup	preamble error, CRC error, SFD error
Decode	display type	decoded bus, tabulated list, details,
		decode layers
	color coding	for different cells types
	data format	hex, octal, binary, signed, unsigned
	decode layer	reversed bits, descrambled bits,
		scrambled bits, ternary symbols
	result export	export of all result data into CSV, XML,
		HTM and PY file formats
Search	search event setup	frame start,
		MAC frame,
		idle frame,
		error conditions
	event settings	same as trigger event settings

# R&S®RTP-K58 Ethernet (1000BASE-T1) serial triggering and decoding

Protocol configuration	signal type	one channel differential, two channels single-ended, optional additional use of reverse channels for signal improvement: one channel differential, two channels
		single-ended
	symbol rate	750 Msymbol/s, adjustable for testing
	thresholds	automatically adjusted during decoding
	source	any analog input channels, math
	1. %	waveforms, reference waveforms
	polarity	normal, inverted
	mode	slave, master
Trigger	trigger event setup	frame start, MAC frame, idle frame, error conditions
	MAC frame setup	destination address (condition =, $\neq$ , <, >, $\geq$ , $\leq$ , in range, out of range), source address (condition =, $\neq$ , <, >, $\geq$ , $\leq$ , in range, out of range), length/type (condition =, $\neq$ , <, >, $\geq$ , $\leq$ , in range, out of range), frame check (condition =, $\neq$ , <, >, $\geq$ , $\leq$ , in range, out of range), data (condition =, $\neq$ , <, >, $\geq$ , $\leq$ , in range, out of range), data index (condition =, <, >, $\geq$ , $\leq$ , range)
	error condition setup	RS-FEC error, out of range error, CRC error, SFD error
Decode	display type	decoded bus, tabulated list, details, decode layers
	color coding	for different cells types
	data format	hex, octal, binary, signed, unsigned
	decode layer	ternary symbols, scrambled bits, descrambled bits, corrected RS-FEC symbols
	result export	export of all result data into CSV, XML, HTM and PY file formats
Search	search event setup	frame start, MAC frame, idle frame, error conditions
	event settings	same as trigger event settings

# R&S®RTP-K60 USB 1.0/1.1/2.0 serial triggering and decoding

Protocol configuration	signal type	single-ended, differential
	protocol type	low, full and high speed
	bit rate	standard bit rates (1.5/12/480 Mbit/s)
	source	any input channel
	probe type	
	for low and full speed	single-ended probe
	for high speed	differential probe (R&S®RT-ZDx)
	auto threshold setup	assisted threshold configuration for USB
		triggering and decoding
Trigger <sup>11</sup>	trigger event setup	start of packet, end of packet, PID token (IN, OUT, SETUP, SOF), PID data (Data0, Data1, Data2 <sup>10</sup> , MData <sup>10</sup> ), PID handshake (ACK, NAK, STALL, NYET <sup>10</sup> ), PID special (PRE <sup>11</sup> , ERR <sup>10</sup> , SPLIT <sup>10</sup> , PING <sup>10</sup> ); bus state (reset <sup>11</sup> , resume <sup>11</sup> , suspend <sup>11</sup> ); error condition
	address, endpoint and frame setup SC, port, SEU, ET check (SPLIT) 11	condition =, ≠, ≥, ≤, in range, out of range
	data setup	data pattern up to 4 byte (hex, decimal, octal, binary or ASCII), bit separately configurable (1, 0 or don't care); condition =, ≠; position based or window based triggering (first occurrence in packet payload)
	error condition	any error, PID error, CRC5 error, CRC16 error, bit stuffing error, unexpected PID, SE1 error <sup>11</sup> and glitching error
Decode	source	any input channel, math waveform
	display type	decoded bus, logical signal, bus + logical signal, tabulated list
	color coding	packet identifier, payload length, frame, address, endpoint, data payload, CRC5, CRC16, error condition
	data format	hexadecimal, decimal, octal, binary, ASCII, unsigned
Search	search event setup	combination of start of packet, PID token (IN, OUT, SETUP, SOF), PID data (Data0, Data1, Data2 <sup>10</sup> , MData <sup>10</sup> ), PID handshake (ACK, NAK, STALL, NYET <sup>10</sup> ), PID special (PRE <sup>11</sup> , ERR <sup>10</sup> , SPLIT <sup>10</sup> , PING <sup>10</sup> ); error condition (any error, PID error, CRC5 error, CRC16 error, bit stuffing error, unexpected PID, SE1 error <sup>11</sup> and glitching error)
	address, endpoint and frame setup SC, port, SEU, ET check (SPLIT)	condition =, $\neq$ , $\geq$ , $\leq$ , in range, out of range
	data setup	data pattern up to 4 byte (hex, decimal, octal, binary or ASCII), bit separately configurable (1, 0 or don't care); condition =, ≠; position based or window based triggering (first occurrence in packet payload)
	error condition	any error, PID error, CRC5 error, CRC16 error, bit stuffing error, unexpected PID, SE1 error <sup>11</sup> and glitching error

<sup>&</sup>lt;sup>10</sup> Only available in high speed.

<sup>&</sup>lt;sup>11</sup> Only available in low and full speed.

# R&S®RTP-K61 USB 3.1 Gen 1 serial triggering and decoding

Protocol configuration	signal type	one channel
	bit rate	auto detected
	auto threshold setup	supported
	source	any analog input channels, math
		channels, reference channels
	scrambling	selectable
	digital signal processing	CTLE continuous time equalizer;
		DFE decision feedback equalizer
Trigger	trigger event setup	frame start
		frame content
		errors
	frame content	USB packet types: TSEQ, TSET1, TSET2, set link function, U2 inactivity timeout, vendor device test, port capability, port configuration, port, config. resp., link delay meas, ACK, NRDY, ERDY, STATUS, STALL, function wake, latency tolerance, bus interval, adjust, host role request, sublink speed, ping, ping response, data packet header, data packet payload, DPP aborted, isochronous timestamp, link command, info, BRST, BDAT, BERC, BCNT, idle; fields according to selected USB packet with content conditions =, ≠, <, >, ≥, ≤, in range, out of range
	errors	CRC, length, value out of range
Decode	display type	decoded bus, tabulated list, details, decode layers
	color coding	cell and frame types
	data format	hexadecimal, octal, binary, ASCII, signed, unsigned, symbols
	decode layer	edges, bits, scrambled symbols, descrambled symbols, bytes
	result export	export of all result data into CSV, XML, HTM and PY file formats
Search	search event setup	frame start
		frame content
		errors
	event settings	same as trigger event settings

# R&S®RTP-K62 USB 3.1 Gen 2 serial triggering and decoding

Protocol configuration	signal type	one channel
	bit rate	auto detected
	auto threshold setup	supported
	source	any analog input channels, math
		channels, reference channels
	scrambling	selectable
	digital signal processing	CTLE continuous time equalizer;
		DFE decision feedback equalizer
Trigger	trigger event setup	frame start
		frame content
		errors
	frame content	USB packet types: TSEQ, TSET1,
		TSET2, set link function, U2 inactivity
		timeout, vendor device test, port
		capability, port configuration, port, config.
		resp., link delay meas, ACK, NRDY,
		ERDY, STATUS, STALL, function wake,
		latency tolerance, bus interval, adjust,
		host role request, sublink speed, ping,
		ping response, data packet header, data
		packet payload, DPP aborted,
		isochronous timestamp, link command,
		info, BRST, BDAT, BERC, BCNT, idle;
		fields according to selected USB packet
		with content conditions =, $\neq$ , <, >, $\geq$ , $\leq$ , in
		range, out of range
	errors	CRC, length, value out of range
Decode	display type	decoded bus, tabulated list, details,
		decode layers
	color coding	cell and frame types
	data format	hexadecimal, octal, binary, ASCII, signed,
		unsigned, symbols
	decode layer	edges, bits, scrambled symbols,
		descrambled symbols, bytes
	result export	export of all result data into CSV, XML,
	100000000000000000000000000000000000000	HTM and PY file formats
Search	search event setup	frame start
	odarsii oveik ostap	frame content
		errors
	event settings	same as trigger event settings
	Ovoni oottiiigo	Junio do inggor event settings

# R&S®RTP-K63 USB power delivery serial triggering and decoding

Protocol configuration	signal type	one channel
	bit rate	auto detected
	source	any analog input channel, logical
		channels, math channels, reference
		channels
	thresholds	data, advertisements
	data details	detailed breakdown selectable
Trigger	trigger event setup	frame start
		frame content
		errors
	frame content	extended, NumDataObjs, MsgID,
		PwrRole/Plug, Rev, DataRole, MsgType,
		voltage advertisements (content
		conditions =, $\neq$ , <, >, $\geq$ , $\leq$ , in range, out of
		range)
	errors	4b/5b, preamble, CRC, length,
		SOP warning
Decode	display type	decoded bus, logical signal, bus + logical
		signal, tabulated list, details, decode
		layers
	color coding	cell and frame types
	data format	hex, octal, binary, signed, unsigned
	decode layer	edges, bits, 4b5b symbols
Search	search event setup	frame start
		frame content
		errors
	event settings	same as trigger event settings

### R&S®RTP-K64 USB 3.1 SSIC serial triggering and decoding

Protocol configuration	signal type	up to 4 lanes differential
	bit rate	auto detected
	source	any analog input channels, math channels, reference channels
	scrambling	selectable
	digital signal processing	CTLE continuous time equalizer; DFE decision feedback equalizer
Trigger	trigger event setup	frame start
		frame content
		errors
	frame content	USB packet types: TSEQ, TSET1, TSET2, set link function, U2 inactivity timeout, vendor device test, port capability, port configuration, port, config. resp., link delay meas, ACK, NRDY, ERDY, STATUS, STALL, function wake, latency tolerance, bus interval, adjust, host role request, sublink speed, ping, ping response, data packet header, data packet payload, DPP aborted, isochronous timestamp, link command, info, BRST, BDAT, BERC, BCNT, idle; fields according to selected USB packet with content conditions =, ≠, <, >, ≥, ≤, in range, out of range
	errors	CRC, length, value out of range
Decode	display type	decoded bus, tabulated list, details, decode layers
	color coding	cell and frame types
	data format	hex, octal, binary, signed, unsigned
	decode layer	off, edges, bits, bytes, 8b/10b symbols, LCC bits, descrambler, lane merge
Search	search event setup	frame start
		frame content
		errors
	event settings	same as trigger event settings

### R&S®RTP-K65 SpaceWire serial triggering and decoding

Protocol configuration	signal type	two channels: strobe and data (differential or single-ended)
	bit rate	auto adjust (strobe + data)
	source	any analog input channels, logical channels <sup>12</sup> , math channels, reference channels
	polarity	normal, inverted
Trigger	trigger event setup	control frame, data pattern, null frame, time code, error condition
	control frame setup	any, FCT, EOP, EEP
	data pattern setup	8 bit (condition =, $\neq$ , <, >, $\geq$ , $\leq$ , in range, out of range)
	time code setup	8 bit (condition =, $\neq$ , <, >, $\geq$ , $\leq$ , in range, out of range)
	errors condition setup	parity, ESC
Decode	display type	decoded bus, logical signal, bus + logical signal, tabulated list, decode layers
	color coding	control frame, data frame, null frame, time code
	data format	hex
Search	search event setup	control frame, data pattern, null frame, time code, error
	event settings	same as trigger event settings

<sup>&</sup>lt;sup>12</sup> SpaceWire protocol trigger on logical channels is not available.

# R&S®RTP-K72 PCI Express 1.1/2.0 serial triggering and decoding

Protocol configuration	signal type	up to four channels (x1, x2, x4 link size) differential signals
	bit rate	predefined 2.5 Gbit/s for Gen 1 and 5 Gbit/s for Gen 2
	source	any analog input channels, math channels, reference channels
	digital signal processing	CTLE continuous time equalizer; DFE decision feedback equalizer
Trigger	trigger event setup	TLP (transaction layer packets), DLLP (data layer packets), ordered sets, errors
	transaction layer packets (TLP)	any type, memory request (32 bit /64 bit, R/W, ordering, snoop, seq. number, Requester ID), I/O transactions, configuration requests, message requests (incl. routing and message code), completion packets (status, completer ID), atomic operation (FetchAdd, SWAP, CAS) for 32 bit/64 bit
	data layer packets (DLLP)	any type, Ack and Nak (seq. number), InitFC1, InitFC2, updateFC (credit type C, NP, Cpl and virtual channel), power management with PM type, vendor packet format. multi-root I/O virtualization (MRDLLP): MRInit (phase, VH FC, mixed type, authorized, device/port type), MRReset (A, VH Group), MRUpdateFC, MRInitFC1 and MRInitFC2 (VL number, VH absent, TLP type, credit type)
	ordered sets	SKP OS, training sequence (TS1, TS2), fast training sequence (FTS), electrical idle OS, electrical idle exit OS, compliance and modified compliance pattern
	errors condition setup	CRC16, ECRC, LCRC, disparity, invalid packets (corrupt header or length errors)
Decode	display type	decoded bus, tabulated list, decode layers, detailed result display for packets
	color coding	TLP, DLLP, K-code, D-code, ordered sets, errors
	data format	K/D symbol, 8 bit format (hex)
	decode layer	8b10b, descrambled 8b10b, bits
	result export	export of all result data into CSV, XML, HTM and PY file formats
Search	search event setup	TLP, DLLP, ordered sets, errors
	event settings	same as trigger event settings

# R&S®RTP-K73 PCI Express 3.0 serial triggering and decoding

Protocol configuration	signal type	up to four channels (x1, x2, x4 link size) differential signals
	bit rate	predefined 8 Gbit/s
	source	any analog input channels, math
		channels, reference channels
	digital signal processing	CTLE continuous time equalizer;
		DFE decision feedback equalizer
Trigger	trigger event setup	TLP (transaction layer packets), DLLP
		(data layer packets), ordered sets, errors
	transaction layer packets (TLP)	any type,
		memory request (32 bit/64 bit, R/W,
		ordering, snoop, seq. number, requester
		ID), I/O transactions, configuration
		requests, message requests (incl. routing
		and message code), completion packets
		(status, completer ID), atomic operation
		(FetchAdd, SWAP, CAS) for 32 bit/64 bit
	data layer packets (DLLP)	any type, Ack and Nak (seq. number),
		InitFC1, InitFC2, updateFC (credit type C,
		NP, Cpl and virtual channel), power
		management with PM type, vendor packet
		format.
		multi-root I/O virtualization (MRDLLP):
		MRInit (phase, VH FC, mixed type,
		authorized, device/port type), MRReset
		(A, VH Group), MRUpdateFC, MRInitFC1
		and MRInitFC2 (VL number, VH absent,
		TLP type, credit type)
	ordered sets	SKP OS, training sequence (TS1, TS2),
		fast training sequence (FTS), electrical
		idle OS, electrical idle exit OS,
		compliance and modified compliance
		pattern
	errors condition setup	CRC16, ECRC, LCRC, disparity, invalid
		packets (corrupt header or length errors)
Decode	display type	decoded bus, tabulated list, decode
		layers, detailed result display for packets
	color coding	TLP, DLLP, K-code, D-code, ordered
		sets, errors
	data format	hex, octal, binary
	decode layer	edges, bits
	result export	export of all result data into CSV, XML,
		HTM and PY file formats
Search	search event setup	TLP, DLLP, ordered sets, errors
	event settings	same as trigger event settings

### R&S®RTP-K81 PCI Express 1.1/2.0 compliance test

The option is used in combination with the free-of-charge R&S®ScopeSuite PC software, which can be downloaded from the Rohde & Schwarz website. R&S®RTP-K81 performs PCle 1.x/2.0 (up to 2.5GT/s) compliance test measurements with R&S®ScopeSuite. R&S®ScopeSuite supports Windows 7, 8 and 10. The chapters after the category refer to PCl Express Base Specification Revision 1.1 and 2.1.

Supported PCIe compliance	e tests	
PCle 1.1	signal quality (4.3.3)	mean unit interval
		data rate
		template tests
		min eye width
		median to max jitter
		differential output voltage
	reference clock (1.32)	differential input high voltage
		differential input low voltage
		duty cycle
		average clock period
		rising edge rate
		falling edge rate
	common-mode output voltage (4.3.3)	RMS AC peak common mode output
		voltage
		AVG DC common mode output voltage
		DC common mode line delta
		DC common mode output voltage variation
	common-mode input voltage (4.3.3)	AC common mode input voltage
PCle 2.0	signal quality (4.3.3)	mean unit interval
		data rate
		template tests
		min eye width
		median to max jitter
		differential output voltage

### R&S®RTP-K83 PCI Express 1.1/2.0/3.0 compliance test

The option is used in combination with the free-of-charge R&S®ScopeSuite PC software, which can be downloaded from the Rohde & Schwarz website. R&S®RTP-K83 performs PCle 1.1/2.0/3.0 compliance test measurements with R&S®ScopeSuite. R&S®ScopeSuite supports Windows 7, 8 and 10.

Supported PCle compliance	e tests	
PCle 1.1	signal quality (4.3.3)	mean unit interval
		data rate
		template tests
		min. eye width
		median to max. jitter
		differential output voltage
	reference clock (1.32)	differential input high voltage
		differential input low voltage
		duty cycle
		average clock period
		rising edge rate
		falling edge rate
	common mode output voltage (4.3.3)	RMS AC peak common mode output
		voltage
		AVG DC common mode output voltage
		DC common mode line delta
		DC common mode output voltage variation
	common mode input voltage (4.3.3)	AC common mode input voltage
PCle 2.0	signal quality (4.3.3)	mean unit interval
		data rate
		template tests
		min eye width
		median to max jitter
		differential output voltage

PCle 3.0	signal quality (4.3.3.13)	mean unit interval
		data rate
		template tests
		min. eye width
	TX base specifications (4.3.3.13.1)	TX voltage with no equalization
		min. swing during electrical idle exit
		sequence ordered set (EIEOS)
		pseudo package loss
		uncorrelated total jitter
		uncorrelated deterministic jitter
		uncorrelated total pulse width jitter
		uncorrelated deterministic pulse width
		jitter
		data dependent jitter
	reference clock (4.3.8)	REF <sub>CLK</sub> frequency
		REF <sub>CLK</sub> jitter
		sSsc frequency range
		ssc deviation
	common-mode output voltage (4.3.3.13)	AC common mode voltage
		(30 kHz to 500 MHz)
		AC common mode voltage
		(<4 GHz lowpass filter)
		transmitter avg dc common mode voltag
		DC common mode voltage
		between d+ and d-
		DC common mode voltage
		during I0 and electrical idle
	TX equalization presets (4.3.3.5.2)	p0-p10 deemphasis
		p0-p10 preshoot

### R&S®RTP-K87 Ethernet compliance test (1000BASE-T1)

The option is used in combination with the free-of-charge R&S®ScopeSuite PC software, which can be downloaded from the Rohde & Schwarz website. R&S®RTP-K87 performs 1000BASE-T1 compliance test measurements with R&S®ScopeSuite. R&S®ScopeSuite supports the R&S®RT-ZF6 frequency converter and R&S®RT-ZF7A and R&S®RT-ZF8 test fixtures; R&S®ScopeSuite supports Windows 7, 8 and 10. The chapters in front of the test cases refer to IEEE 802.3-2018. OPEN Alliance ECU specification supported, where applicable.

Supported 1000BASE-T1 compliance tests		
1000BASE-T1	97.5.3.3 transmitter timing jitter master mode	
	97.5.3.3 transmitter timing jitter slave mode	
	97.5.3.3 transmitter timing MDI jitter	
	97.5.3.6 transmitter clock frequency	
	97.5.3.2 transmitter distortion	
	97.5.3.4 transmitter power spectral density (PSD)	
	97.5.3.4 transmitter power level	
	97.5.3.5 transmitter peak differential output	
	97.5.3.1 maximum output droop	
	97.7.2.1 MDI return loss	
	97.7.2.2 MDI mode conversion loss	
	MDI adapter verification	

### R&S®RTP-K88 Ethernet compliance test (MGBASE-T1)

The option is used in combination with the free-of-charge R&S®ScopeSuite PC software, which can be downloaded from the Rohde & Schwarz website. R&S®RTP-K88 performs MGBASE-T1 compliance test measurements with R&S®ScopeSuite. R&S®ScopeSuite supports R&S®RT-ZF7A and R&S®RT-ZF8 test fixtures; R&S®ScopeSuite supports Windows 7, 8 and 10. The chapters in front of the test cases refer to IEEE P802.3ch.

Supported MGBASE-T1 compliance tests		
MGBASE-T1 (2.5/5/10G)	149.5.2.1 maximum output droop	
	149.5.2.2 transmitter linearity	
	149.5.2.3 transmitter timing jitter master	
	149.5.2.3 transmitter timing jitter slave	
	149.5.2.3.1 transmit MDI random jitter in master mode	
	149.5.2.3.2 transmit MDI deterministic jitter in master mode	
	149.5.2.4 transmitter power spectral density (PSD) and power	
	level	
	149.5.2.5 transmitter peak differential output	
	149.5.2.6 transmitter clock frequency	
	149.8.2.1 MDI return loss	

### R&S®RTP-K89 Ethernet compliance test (10BASE-T1)

The option is used in combination with the free-of-charge R&S®ScopeSuite PC software, which can be downloaded from the Rohde & Schwarz website. R&S®RTP-K89 performs 10BASE-T1 compliance test measurements with R&S®ScopeSuite. R&S®ScopeSuite supports the R&S®RT-ZF7A and R&S®RT-ZF8 test fixtures; R&S®ScopeSuite supports Windows 7, 8 and 10. The chapters in front of the test cases refer to IEEE P802.3cg.

Supported 10BASE-T1 compliance tests		
10BASE-T1S	147.5.4.1 transmitter output voltage	
	147.5.4.3 transmitter timing jitter	
	147.5.4.2 transmitter output droop	
	147.5.4.4 transmitter power spectral density (PSD)	
	147.7.2 MDI return loss	
	147.7.3 MDI mode conversion	
10BASE-T1L	146.5.4.1 transmitter output voltage	
	146.5.4.3 transmitter timing jitter	
	146.5.4.5 transmitter clock frequency	
	146.5.4.4 transmitter power spectral density (PSD) and power	
	level	
	146.8.3 MDI return loss	
	146.8.4 MDI mode conversion	

# R&S®RTP-K91 DDR3/DDR3L/LPDDR3 signal integrity debug and compliance test

The option is used in combination with the free-of-charge R&S®ScopeSuite PC software, which can be downloaded from the Rohde & Schwarz website. R&S®RTP-K91 performs DDR3 (JESD79-3F), DDR3L(JESD79-3-1A.01) and LPDDR3 (JEDS209-3C) compliance test measurements with R&S®ScopeSuite. Furthermore, it enables the DDR3 decode capability to separate read and write bursts as well as the eye analysis function for mask testing on the oscilloscope. R&S®ScopeSuite supports Windows 7, 8 and 10.

Supported DDR3 compliance t		
Γiming tests	clock timing (12.1)	tCK(avg) (12.1.1)
-		tCK(abs) (12.1.2)
		tCL(avg) (12.1.3)
		tCH(avg) (12.1.3)
		tJIT(per) (12.1.4)
		tJIT(duty) (12.1.4)
		tJIT(cc) (12.1.5)
	1	tERR(nper) (12.1.6)
	data timing (4.13.2, 13.4, 13.6)	tDS(base) (13.6)
		tDH(base) (13.6)
		tDS(derate) (13.6)
		tDH(derate) (13.6)
		tHZ (4.13.2)
		tLZ (4.13.2)
		tDIPW (13.4 note 28)
		tDQSQ (4.13.2)
		tQH (4.13.2)
	strobe timing (4.13, 4.14, 8.3.1)	tDQSCK (4.13.2)
		tLZ (4.13.2)
		tHZ (4.13.2)
		tRPRE (4.13.2)
		tRPST (4.13.2)
		tQSH (4.13.2)
		tQSL (4.13.2)
		tDQSS (4.14.2)
		tDQSH (4.14.2)
		tDQSL (4.14.2)
		tDSS (4.14.2)
		tDSH (4.14.2)
		tWPST (4.14.2)
		tWPRE (4.14.2)
		tDVAC (strobe) (8.3.1)
		tDVAC (clock) (8.3.1)
	command timing (13.5)	tIS (13.5)
		tIS (derated) (13.5)
		tIH (13.5)
		tlH (derated) (13.5)
		tlPW (13.5)
		tVAC (CA) (13.5)
	address timing (13.5) DDR3 and DDR3L	tlS (13.5)
	addiess tilling (13.3) DDR3 and DDR3L	
		tIS (derated) (13.5)
		tlH (13.5)
		tlH (derated) (13.5)
		tIPW (13.5)
		tVAC (CA) (13.5)
	address timing (4.2) LPDDR3	tISCA (4.2)
		tIHCA (4.2)
		tIPWCA (4.2)
		tVAC (CA) (13.5)
	chip select timing (13.5) DDR3 and	tIS (13.5)
	DDR3L	tlS (derated) (13.5)
	DENOL	tlH (13.5)
		tlH (derated) (13.5)
		tIPW (13.5)
	chip select timing (4.2) LPDDR3	tISCS (4.2)
		tIHCS (4.2)
		tIPWCS (4.2)
		tVAC(CS) (11.5)

Electrical tests single-ended	input slew rate for ADD and CMD DDR3	SR(tIS) rising
measurements	and DDR3L (8.5, 13.5) LPDDR3 (7.6,	SR(tIS) falling
modearomento	11.5)	SR(tIH) rising
	11.0)	SR(tIH) falling
	input slew rate for DQ and DM DDR3 and	SR(tIS) rising
	DDR3L (8.5, 13.6) LPDDR3 (7.6, 11.6)	SR(tIS) falling
	BBROE (6.6, 16.6) El BBRO (7.6, 11.6)	SR(tIH) rising
		SR(tIH) falling
	AC and DC input levels for ADD and CMD	
	DDR3(8.1.1) DDR3L(3.1) LPDDR3(7.1.1)	VIH (AC)
	DDR3(6.1.1) DDR3L(3.1) LPDDR3(7.1.1)	VIL (AC)
		VIH (DC)
	A O instant learning for OK and DOO (0.0.0)	VIL (DC)
	AC input levels for CK and DQS (8.3.3)	VSEH (AC)
		VSEL (AC)
	output slew rate for DQ (9.3)	SRQse rising
	10 100 11 11 1000	SRQse falling
	AC and DC output levels for DQ (9.2)	VOH(AC)
		VOL(AC)
		VOH(DC)
		VOL(DC)
	AC overshoot and undershoot for ADD	overshoot amplitude
	and CMD (9.6.1)	overshoot area
		undershoot amplitude
		undershoot area
	AC overshoot and undershoot for CK, DQ,	overshoot amplitude
	DQS and DM (9.6.2)	overshoot area
		undershoot amplitude
		undershoot area
Electrical tests differential measurements	AC input levels for CK and DQS (8.3)	VIHdiff (AC)
		VILdiff (AC)
	AC differential cross point voltage for CK (8.4)	VIX (AC)
	differential output slew rate for DQS (9.4)	SRQdiff rising
		SRQdiff falling
	differential AC output levels for DQS (9.2)	VOHdiff(AC)
		VOLdiff(AC)
Debug	trigger write cycle	configures the scope to trigger on a write
•		cycle
	trigger read cycle	configures the scope to trigger on a read cycle
DDR3 decoding		1 · · · ·
Protocol configuration	signal type	DQ, DQS
	bit rate	adjustable
	threshold setup	manual threshold/hysteresis configuration
	source	analog channels
Decode	display type	decoded bus, tabulated list, details
20000	color coding	read frame, write frame
	data format	hex, octal, binary, signed, unsigned
	data format decode layer	edges, bits, words
Search	search event setup	frame content, error
Calon	•	data; conditions =, ≠, <, ≤, >, ≥, in range,
	frame content	out of range
	error	length, frame incomplete

DDR3 eye diagram General description	The DDR3 eye diagram allows the user to generate eye diagrams from long multi-		
Conordi decemplion	period acquisitions of clock signals and serial data signals. It allows the fine control of		
	the signal content that contributes to the eye diagram and enables the advanced analysis, measurement, mask test and navigation functions.		
General configuration	number of eye diagram instances	up to 4; independently configurable	
General Configuration	main source	analog channels, math channels,	
		reference channels	
	timing reference source	analog channels, math channels, reference channels	
	horizontal settings	range, position; expressed in absolute time or relative to user-defined bit rate	
Display	persistence	50 ms to 50 s, or infinite	
	trace colors	predefined or user-defined color tables	
	eye stripe	displays position of eye diagram slices	
		and masks violations time-correlated to	
		the main source waveform; always	
		enabled, for mask tests only, disabled.	
Qualification	gate		
	position	start, stop; absolute time or relative to	
	·	display in percent	
	coupling	none, cursor #, zoom #	
	signal		
	source	analog channels, math channels,	
		reference channels	
	condition	greater than, less than; relative to	
		selected reference level	
Filter	DDR3 protocol		
	frame type	any, read frame, write frame	
	error	length	
	bit sequence		
	mode	all, level transition, constant level, bit pattern	
	bit pattern setup	up to 8 prefix bits and up to 5 suffix bits with respect to central eye diagram bit	
Mask testing	mask test results	, sopeon to comman eye anagram bit	
ividak testirig	counters	acquisitions, slices, sample hits, slice hits	
	Southors	fail rate	
	violation details	number and position of mask violation,	
		expressed as time instant and slice index	
	navigation and zoom	use zoom coupling to navigate to violation	
		upon clicking the corresponding table itel	

# R&S®RTP-K92 eMMC compliance test

The option is used in combination with the free-of-charge R&S®ScopeSuite PC software, which can be downloaded from the Rohde & Schwarz website. R&S®RTP-K92 performs eMMC (HS200, HS400) compliance test measurements with R&S®ScopeSuite. R&S®ScopeSuite supports Windows 7, 8 and 10.

Supported eMMC compliance to	ests	
HS200 (JESD84-B50)	CLK (10.5.2, 10.8.1)	bus signal levels tests (VIH, VIL)
		interface timing tests
		(t <sub>Period</sub> , rise time, fall time, duty cycle)
	CMD push pull (10.5.2, 10.8.1)	bus signal levels tests
		(VIH, VIL, VOH, VOL)
		interface timing tests
		(setup time, hold time)
	CMD open drain (10.5.1)	bus signal levels tests (VOH, VOL)
	DAT data write (10.5.2, 10.8.1)	bus signal levels tests (VIH, VIL)
		interface timing tests
		(setup time, hold time)
	DAT data read (10.5.2, 10.8.1)	bus signal levels tests (VOH, VOL)
HS400 (JESD84-B50)	CLK (10.5.2, 10.10.1)	bus signal levels tests (VIH, VIL)
		interface timing tests
		(t <sub>Period</sub> , slew rate, duty cycle distortion,
		minimum pulse width)
	CMD push pull (10.5.2, 10.10.1)	bus signal levels tests
		(VIH, VIL, VOH, VOL)
		interface timing tests
		(setup time, hold time)
	CMD open drain (10.5.1)	bus signal levels tests (VOH, VOL)
	DAT data write (10.5.2, 10.10.1)	bus signal levels tests (VIH, VIL)
		interface timing tests
		(setup time, hold time, slew rate)
	DAT data read (10.5.2, 10.10.2)	bus signal levels tests (VOH, VOL)
		interface timing tests (output skew, output
		hold skew, slew rate)
	data strobe for data read (10.5.2,	bus signal levels tests (VOH, VOL)
	10.10.1)	interface timing tests
		(t <sub>Period</sub> , slew rate, duty cycle distortion,
		minimum pulse width)

### R&S®RTP-K93 DDR4/LPDDR4 signal integrity debug and compliance test

The option is used in combination with the free-of-charge R&S®ScopeSuite PC software, which can be downloaded from the Rohde & Schwarz website. R&S®RTP-K93 performs DDR4 (JESD79-4B), LPDDR4 (JESD209-4B) and LPDDR4X(JESD209-4-1) compliance test measurements with R&S®ScopeSuite. Furthermore, it enables the DDR4 decode capability to separate read and write bursts as well as the eye analysis function for mask testing on the oscilloscope. R&S®ScopeSuite supports Windows 7, 8 and 10.

Timing tests	clock timing (13.3)	tCK(abs) (13.3.1)
<b>G</b>		tCK(avg) (13.3.2)
		tCL(avg) (13.3.3)
		tCH(avg) (13.3.3)
		tJIT(per) (13.3.4)
		tJIT(duty) (13.3.4)
		tJIT(cc) (13.3.4)
		tERR(nper) (13.3.4)
	data timing (4.24.1.2, 4.24.1.3)	tDQSQ (4.24.1.2)
	,	tQH (4.24.1.2)
		tLZ(DQ) (4.24.1.3)
		tHZ(DQ) (4.24.1.3)
	strobe timing (8.3.1, 4.24.1, 4.25.1)	tDVAC(Strobe) (8.3.1)
		tDVAC(Clock) (8.3.1)
		tLZ(DQS) (4.24.1)
		tHZ(DQS (4.24.1)
		tDQSCK (4.24.1)
		tRPRE (4.24.1)
		tRPST (4.24.1)
		tQSH (4.24.1)
		tQSL (4.24.1)
		tDQSS (4.25.1)
		tDQSH (4.25.1)
		tDQSL (4.25.1)
		tDSS (4.25.1)
		tDSH (4.25.1)
		tWPRE (4.25.1)
	command timing (13.7)	tIS(base) (13.7)
		tIH(base) (13.7)
		tIPW (13.7)
	address timing (13.7)	tIS(base) (13.7)
		tlH(base) (13.7)
		tIPW (13.7)
	chip select timing (13.7)	tIS(base) (13.7)
		tlH(base) (13.7)
		tIPW (13.7)

AC and DC input levels for ADD and CMD   (8.1)   (1.			1
AC input levels for CK (8.3.3)   VSEH(AC)	Electrical tests single-ended	AC and DC input levels for ADD and CMD	VIH(AC)
AC input levels for CK (8.3.3)   VSEH(AC)	measurements	(8.1)	VIL(AC)
AC input levels for CK (8.3.3)   VSEHAC)   VSELAC			
AC input levels for CK (8.3.3)   VSEH(AC)   VSEL(AC)			
AC overshoot and undershoot for ADD, CMD (8.3.4)   VAOSP		101 11 1 ( 01((0.00)	
AC overshoot and undershoot for ADD, CMD (8.3.4)		AC input levels for CK (8.3.3)	
CMD (8.3.4)			VSEL(AC)
CMD (8.3.4)		AC overshoot and undershoot for ADD.	VAOSP
AC overshoot and undershoot for CK		-	
AC overshoot and undershoot for CK (8.3.5)		CIVID (6.3.4)	
AAOS1			VAUS
AAOS1			AAOS2
AC overshoot and undershoot for CK (8.3.5)  AC overshoot and undershoot for CK (8.3.5)  AC overshoot and undershoot for DQ, VCUS ACOS2 ACOS1 ACUS ACOS2 ACOS1 ACUS VDOSP VDOS VDUS VDUSP ADOS2 ADOS1 ADUS1 ADUS2 input slew rate for ADD and CMD (8.4.2) SR(IS) rising SR(IH) rising SR(IH			
AC overshoot and undershoot for CK (8.3.5)   VCOS			
(8.3.5)   VCOS   VCUS   ACOS2   ACOS1   ACUS   ACU			
VCUS     ACOS2     ACOS1     ACUS     ACOS1     ACUS     ACUS     ACUS     ACUS     ACUS     ACUS     ACUS     ACUS     ACUS     VDOSP     VDOS     VDUS     VDUS     VDUS     ADOS2     ADOS1     ADUS1     ADUS1     ADUS2     SR(IKI) failing		AC overshoot and undershoot for CK	
VCUS     ACOS2     ACOS1     ACUS     ACOS1     ACUS     ACUS     ACUS     ACUS     ACUS     ACUS     ACUS     ACUS     ACUS     VDOSP     VDOS     VDUS     VDUS     VDUS     ADOS2     ADOS1     ADUS1     ADUS1     ADUS2     SR(IKI) failing		(8.3.5)	VCOS
AC overshoot and undershoot for DQ, ACUS ACUS ACUS ACUS ACUS ACUS ACUS ACUS			
AC overshoot and undershoot for DQ, DQS and DM (8.3.6)  AC overshoot and undershoot for DQ, VDOSP  VDOS  VDUSP  ADOS2  ADOS1  ADUS1  ADUS2  ADUS1  ADUS2  SRILS) rising  SRILS) rising  SRILH) rising  SROse			
AC overshoot and undershoot for DQ, DQS and DM (8.3.6)  PQS and DM (8.3.6)  AC overshoot and undershoot for DQ, VDOS VDUS VDUS VDUS VDUS VDUS ADOS2 ADOS2 ADOS1 ADUS1 ADUS1 ADUS1 ADUS2  Input slew rate for ADD and CMD (8.4.2)  AC & DC output levels for DQ (9.2)  AC & DC output levels for DQ (9.2)  AC & DC output levels for DQ (9.2)  Output slew rate for DQ (9.4)  Output slew rate for DQ (9.4)  AC and DC input levels for CK (8.3.2)  Final DC (100 VOL(AC) VOL(			
AC overshoot and undershoot for DQ, DQS and DM (8.3.6)  ROS and DM (8.3.6)  AC S DC output levels for DQ (9.2)  Filterical tests differential measurements  AC and DC input levels for CK (8.3.2)  Filterical tests differential measurements  AC and DC input levels for CK (8.3.2)  Filterical tests differential measurements  AC and DC input levels for CK (8.3.2)  Filterical tests differential measurements  AC and DC input levels for CK (8.3.2)  Filterical tests differential measurements  AC and DC input levels for CK (8.3.2)  Filterical tests differential measurements  AC and DC input levels for CK (8.3.2)  Filterical tests differential measurements  AC and DC input levels for CK (8.3.2)  Filterical tests differential measurements  AC and DC input levels for CK (8.3.2)  Filterical tests differential measurements  AC and DC input levels for CK (8.3.2)  Filterical tests differential measurements  AC and DC input levels for CK (8.3.2)  Filterical tests differential measurements  AC and DC input levels for CK (8.3.2)  Filterical tests differential measurements  AC and DC input levels for CK (8.3.2)  Filterical tests differential measurements  AC and DC input levels for CK (8.3.2)  Filterical tests differential measurements  AC and DC input levels for CK (8.3.2)  Filterical tests differential measurements  AC and DC input levels for CK (8.3.2)  Filtridif(CC)  VILdiff(AC)  VILdiff(AC)  VILdiff(CC)  VILdiff(AC)  VILdiff(AC)  VILDiff(Peak  VILDiff(Peak  VILDiff(Peak  VILDiff(Peak  VILDiff(Peak  VILDiff(Peak  VILDiff(Peak  VILDiff(AC)  VOLdiff(AC)  VOLdiff(AC)  VOLdiff(AC)  DC (AC)  VOL(AC)			
AC overshoot and undershoot for DQ, DQS and DM (8.3.6)  ROS and DM (8.3.6)  AC S DC output levels for DQ (9.2)  Filterical tests differential measurements  AC and DC input levels for CK (8.3.2)  Filterical tests differential measurements  AC and DC input levels for CK (8.3.2)  Filterical tests differential measurements  AC and DC input levels for CK (8.3.2)  Filterical tests differential measurements  AC and DC input levels for CK (8.3.2)  Filterical tests differential measurements  AC and DC input levels for CK (8.3.2)  Filterical tests differential measurements  AC and DC input levels for CK (8.3.2)  Filterical tests differential measurements  AC and DC input levels for CK (8.3.2)  Filterical tests differential measurements  AC and DC input levels for CK (8.3.2)  Filterical tests differential measurements  AC and DC input levels for CK (8.3.2)  Filterical tests differential measurements  AC and DC input levels for CK (8.3.2)  Filterical tests differential measurements  AC and DC input levels for CK (8.3.2)  Filterical tests differential measurements  AC and DC input levels for CK (8.3.2)  Filterical tests differential measurements  AC and DC input levels for CK (8.3.2)  Filterical tests differential measurements  AC and DC input levels for CK (8.3.2)  Filterical tests differential measurements  AC and DC input levels for CK (8.3.2)  Filtridif(CC)  VILdiff(AC)  VILdiff(AC)  VILdiff(CC)  VILdiff(AC)  VILdiff(AC)  VILDiff(Peak  VILDiff(Peak  VILDiff(Peak  VILDiff(Peak  VILDiff(Peak  VILDiff(Peak  VILDiff(Peak  VILDiff(AC)  VOLdiff(AC)  VOLdiff(AC)  VOLdiff(AC)  DC (AC)  VOL(AC)			ACUS
DQS and DM (8.3.6)   VDOS   VDUS   ADOS2   ADUS1   ADUS1   ADUS2   SR(IIS) falling   SR(IIS) falling   SR(IIIS) falling   SR(IIIS) falling   SR(IIIS) falling   SR(IIII) falling   VOH(AC)		AC overshoot and undershoot for DO	
VDUS   VDUSP   ADOS2   ADOS1   ADUS2   ADUS			
VDUSP		DQ3 8110 DIVI (0.3.0)	
ADOS2   ADOS1   ADUS1   ADUS2   ADUS1   ADUS2			
ADOS2   ADOS1   ADUS1   ADUS2   ADUS1   ADUS2			VDUSP
ADOS1 ADUS2			
input slew rate for ADD and CMD (8.4.2)  AC & DC output levels for DQ (9.2)  AC & DC output levels for DQ (9.2)  OVH(AC)  VOH(AC)  VOH(CC)  VOH(CC)  OULOC)  output slew rate for DQ (9.4)  SRQse rising  SRQse falling  VHidiff(DC)  VILdiff(AC)  VILdiff(AC)  VILdiff(CC)  input slew rate for CK (8.3.2)  input slew rate for CK (8.4.1)  SRdiff rising  DDR4 decoding  Protocol configuration  DDR4 decoding  Protocol configuration  Signal type  bit rate  diput slew rate for DQS (9.5)  SR diff rising  SQQdiff ralling  DQ, DQS  bit rate  manual threshold/hysteresis configuration  source  analog channels  Decode  descode bus, tabulated list, details read frame, write frame  data format  hex, octal, binary, signed, unsigned  decode layer  edges, bit, words  Frame content, error  data; conditions = , ≠, <, ≤, ≥, ≥, in range,  out of range			
input slew rate for ADD and CMD (8.4.2)    SR(tts) rising   SR(tth) rising   SR(tth) falling   SR(tth			
Input slew rate for ADD and CMD (8.4.2)   SR(ItS) rising   SR(ItH) risi			
Input slew rate for ADD and CMD (8.4.2)   SR(ItS) rising   SR(ItH) risi			ADUS2
SR(IIS) falling   SR(IIH) rising   SR(IIH) rising   SR(IIH) rising   SR(IIH) rising   SR(IIH) falling   VOH(AC)   VOH(AC)   VOH(AC)   VOH(AC)   VOH(DC)   VOL(AC)   VOH(DC)   VOL(DC)		input slew rate for ADD and CMD (8.4.2)	
SR(IIH) rising   SR(IIH) falling   VOH(AC)   VOH(AC)   VOH(DC)   VOL(DC)   VOL(DC)   SROse falling   SRQse falling   SR(IIIH) falling   SR(IIH) f		input siew rate for ADD and GMD (0.4.2)	
AC & DC output levels for DQ (9.2)			
AC & DC output levels for DQ (9.2)    VOH(AC)     VOL(DC)     VOL			SR(tIH) rising
AC & DC output levels for DQ (9.2)    VOH(AC)     VOL(DC)     VOL			SR(tIH) falling
VOL(AC)   VOH(DC)   VOH(DC)   VOH(DC)   VOH(DC)   VOL(DC)		AC & DC output levels for DO (9.2)	
VOH(DC)   VOL(DC)   SRQse rising   SRQse falling   SRQse falling   SRQse falling   SRQse falling   VIHdiff(AC)   VILdiff(AC)   VILdiff(AC)   VILdiff(AC)   VILdiff(AC)   VILdiff(DC)   VILDiffPeak   VILDiffPea		AO & DO Output levels for DQ (5.2)	
Duty to sew rate for DQ (9.4)   SRQse failing			
Electrical tests differential measurements  AC and DC input levels for CK (8.3.2)  AC and DC input levels for CK (8.3.2)  VIHdiff(AC)  VILdiff(AC)  VILdiff(BC)  VILdiff(DC)  VILdiff(DC)  VILdiff(DC)  VILdiff(DC)  SRdiff rising  SRdiff falling  differential cross point voltage for CK (8.5)  AC input levels for DQS (8.7.2)  VINDiffPeak  VILDiffPeak  VILDi			VOH(DC)
Electrical tests differential measurements  AC and DC input levels for CK (8.3.2)  AC and DC input levels for CK (8.3.2)  VIHdiff(AC)  VILdiff(AC)  VILdiff(BC)  VILdiff(DC)  VILdiff(DC)  VILdiff(DC)  VILdiff(DC)  SRdiff rising  SRdiff falling  differential cross point voltage for CK (8.5)  AC input levels for DQS (8.7.2)  VINDiffPeak  VILDiffPeak  VILDi			VOL(DC)
Electrical tests differential measurements  Respond a point levels for CK (8.3.2)  Electrical tests differential measurements  AC and DC input levels for CK (8.3.2)  VIHdiff(AC)  VILdiff(DC)  VILdiff(DC)  VILdiff(DC)  VILdiff(DC)  VILdiff(DC)  VILdiff(DC)  VILdiff(DC)  VILdiff(DC)  VILdiff(BC)  VIX(CK)  AC input levels for DQS (8.7.2)  VIHDiffPeak  VILDiffPeak  VILDiffPeak  VILDiffPeak  VILDiffPeak  VILDiffPeak  VILDiffPeak  VILDiffPeak  VILdiff(AC)  VOLdiff(AC)  SRdiff falling  Rediff falling  SRdiff falling  VOHdiff(AC)  VOLdiff(AC)  VOLdiff(AC)  VOLdiff(AC)  SRQdiff falling  DDR4 decoding  Protocol configuration  Signal type  bit rate  threshold setup  manual threshold/hysteresis configuration  source  analog channels  Decode  Decode  display type  decoded bus, tabulated list, details  color coding  read frame, write frame  data format  hex, octal, binary, signed, unsigned  decode layer  decode layer  search event setup  frame content, error  frame, out of range		output slew rate for DQ (9.4)	
Electrical tests differential measurements  AC and DC input levels for CK (8.3.2)  VIHdiff(AC)  VILdiff(AC)  VIHdiff(DC)  VIHdiff(DC)  VILdiff(DC)  SRdiff rising  SRdiff rising  SRdiff falling  VILDiffPeak  SRdiff rising  SRdiff falling  VOHdiff(AC)  VOLdiff(AC)  SRQdiff rising  SQdiff falling  VOHdiff(AC)  VOLdiff(AC)  SRQdiff rising  SQdiff falling  DDR4 decoding  Protocol configuration  Signal type  bit rate  threshold setup  bit rate  display type  color coding  read frame, write frame  data format  decode layer  decoded bus, tabulated list, details  read frame, write frame  data format  decode layer  decoded seges, bits, words  frame content, error  frame content  frame content, error  frame content, error  frame content, error  frame content, error  data; conditions =, ≠, <, ≤, >, ≥, in range, out of range		output siew rate for Ba (o.4)	
VILdiff(AC)   VIHdiff(DC)   VIHdiff(DC)   VILdiff(DC)   VILdiff(DC)   VILdiff(DC)   VILdiff(DC)   VILdiff(DC)   VILdiff(DC)   SRdiff rising   SRdiff rising   SRdiff falling   SRdiff falling   SRdiff falling   VIX(CK)   AC input levels for DQS (8.7.2)   VIHDiffPeak   VILDiffPeak			•
VIHdiff(DC)   VILdiff(DC)   VILdiff(DC)   VILdiff(DC)   VILdiff(DC)   VILdiff(DC)   VILdiff(DC)   VILdiff(DC)   SRdiff rising   SRdiff falling   SRdiff falling   VIX(CK)   AC input levels for DQS (8.7.2)   VIHDiffPeak   VILDiffPeak   VIL	Electrical tests differential measurements	AC and DC input levels for CK (8.3.2)	VIHdiff(AC)
VIHdiff(DC)   VILdiff(DC)   VILdiff(DC)   VILdiff(DC)   VILdiff(DC)   VILdiff(DC)   VILdiff(DC)   VILdiff(DC)   SRdiff rising   SRdiff falling   SRdiff falling   VIX(CK)   AC input levels for DQS (8.7.2)   VIHDiffPeak   VILDiffPeak   VIL			VILdiff(AC)
Input slew rate for CK (8.4.1)   SRdiff rising   SRdiff falling			
input slew rate for CK (8.4.1)  differential cross point voltage for CK (8.5)  AC input levels for DQS (8.7.2)  VIX(CK)  AC input levels for DQS (8.7.2)  vIIDiffPeak  VILDiffPeak  VILDiffPeak  VILDiffPeak  VIDiffPeak  VIDiffPeak  input slew rate for DQS (8.7.5)  SRdiff rising  SRdiff falling  VOHdiff(AC)  VOLdiff(AC)  VOLdiff(AC)  VOLdiff (AC)  SRQdiff rising  SQQdiff falling  DDR4 decoding  Protocol configuration  signal type  bit rate  adjustable  threshold setup  manual threshold/hysteresis configuration  source  analog channels  Decode  display type  decoded bus, tabulated list, details  color coding  read frame, write frame  data format  data format  decode layer  Search event setup  frame content, error  frame content  frame content, error  frame content  data; conditions =, ≠, <, ≤, >, ≥, in range, out of range			
differential cross point voltage for CK (8.5)   VIX(CK)     AC input levels for DQS (8.7.2)   VIHDiffPeak     vill DiffPeak   VILDiffPeak     input slew rate for DQS (8.7.5)   SRdiff rising     SRdiff falling     differential AC output levels for DQS (9.3)   VOHdiff(AC)     VOLdiff(AC)   VOLdiff(AC)     VOLdiff(AC)   VOLdiff(AC)     VORDIFF (alling     SQQdiff falling     DDR4 decoding     Protocol configuration   Signal type   DQ, DQS     bit rate   adjustable     threshold setup   manual threshold/hysteresis configuration     source   analog channels     decoded bus, tabulated list, details     color coding   read frame, write frame     data format   hex, octal, binary, signed, unsigned     decode layer   edges, bits, words     Search   Search event setup   frame content, error     frame content   data; conditions =, ≠, <, ≤, >, ≥, in range, out of range     vill DiffPeak   VIX(CK)     VIHDiffPeak   VIX(CK)     VIXICK)   VIX(CK)     SRdiff rising   SRdiff rising     SRdiff rising   SRdiff rising     SRdiff rising   SRdiff rising     SRdiff rising     SRdiff rising     SRdiff rising     SRdiff rising     SRdiff rising     SRdiff rising     SRdiff rising     SRdiff rising     SRdiff rising     SRdiff rising     SRdiff rising     SRdiff rising     SRdiff rising     SRdiff rising     SRdiff rising     SRdiff rising     SRdiff rising     SRdiff raling     SRdiff rising     SRdiff raling     SRdiff r			
differential cross point voltage for CK (8.5)       VIX(CK)         AC input levels for DQS (8.7.2)       VIHDiffPeak         VILDiffPeak       VILDiffPeak         VILDiffPeak       VILDiffPeak         VILDiffPeak       VILDiffPeak         VILDiffPeak       VILDiffPeak         VILDiffPeak       SRdiff rising         SRdiff falling       VOLdiff(AC)         VOLdiff(AC)       VOLdiff(AC)         VOLdiff(AC)       VOLdiff(AC)         SRQdiff rising       SQQdiff falling         DPA       DQ, DQS         bit rate       adjustable         threshold setup       manual threshold/hysteresis configuration         source       analog channels         Decode       display type       decoded bus, tabulated list, details         color coding       read frame, write frame         data format       hex, octal, binary, signed, unsigned         decode layer       edges, bits, words         Search       search event setup       frame content, error         frame content, error       data; conditions =, ≠, <, ≤, >, ≥, in range, out of range		input slew rate for CK (8.4.1)	SRdiff rising
differential cross point voltage for CK (8.5)       VIX(CK)         AC input levels for DQS (8.7.2)       VIHDiffPeak         VILDiffPeak       VILDiffPeak         VILDiffPeak       VILDiffPeak         VILDiffPeak       VILDiffPeak         VILDiffPeak       VILDiffPeak         VILDiffPeak       SRdiff rising         SRdiff falling       VOLdiff(AC)         VOLdiff(AC)       VOLdiff(AC)         VOLdiff(AC)       VOLdiff(AC)         SRQdiff rising       SQQdiff falling         DPA       DQ, DQS         bit rate       adjustable         threshold setup       manual threshold/hysteresis configuration         source       analog channels         Decode       display type       decoded bus, tabulated list, details         color coding       read frame, write frame         data format       hex, octal, binary, signed, unsigned         decode layer       edges, bits, words         Search       search event setup       frame content, error         frame content, error       data; conditions =, ≠, <, ≤, >, ≥, in range, out of range			SRdiff falling
AC input levels for DQS (8.7.2)    VIHDiffPeak		differential cross point voltage for CK (9.5)	
VILDiffPeak   input slew rate for DQS (8.7.5)   SRdiff rising   SRdiff falling   SRdiff falling   VOHdiff(AC)   VOLdiff(AC)   VOLdiff(AC)   VOLdiff(AC)   VOLdiff(AC)   SQdiff rising   SQdiff falling   SQdiff			
input slew rate for DQS (8.7.5)    SRdiff rising   SRdiff falling		AC input levels for DQS (8.7.2)	VIHDIffPeak
SRdiff falling       differential AC output levels for DQS (9.3)     VOHdiff(AC)       VOLdiff(AC)     VOLdiff(AC)       SRQdiff rising     SQQdiff falling       DDR4 decoding       Protocol configuration       Signal type     DQ, DQS       bit rate     adjustable       threshold setup     manual threshold/hysteresis configuration       source     analog channels       Decode     display type     decoded bus, tabulated list, details       color coding     read frame, write frame       data format     hex, octal, binary, signed, unsigned       decode layer     edges, bits, words       Search     search event setup     frame content, error       frame content, error     data; conditions =, ≠, <, ≤, >, ≥, in range, out of range			VILDiffPeak
SRdiff falling       differential AC output levels for DQS (9.3)     VOHdiff(AC)       VOLdiff(AC)     VOLdiff(AC)       SRQdiff rising     SQQdiff falling       DDR4 decoding       Protocol configuration       Signal type     DQ, DQS       bit rate     adjustable       threshold setup     manual threshold/hysteresis configuration       source     analog channels       Decode     display type     decoded bus, tabulated list, details       color coding     read frame, write frame       data format     hex, octal, binary, signed, unsigned       decode layer     edges, bits, words       Search     search event setup     frame content, error       frame content, error     data; conditions =, ≠, <, ≤, >, ≥, in range, out of range		input slew rate for DQS (8.7.5)	SRdiff rising
differential AC output levels for DQS (9.3)     VOHdiff(AC)       VOLdiff(AC)     VOLdiff(AC)       VOLdiff(AC)     SRQdiff rising       SQQdiff falling     SQQdiff falling       DPR4 decoding       Protocol configuration       Signal type     DQ, DQS       bit rate     adjustable       threshold setup     manual threshold/hysteresis configuration       source     analog channels       decoded bus, tabulated list, details       color coding     read frame, write frame       data format     hex, octal, binary, signed, unsigned       decode layer     edges, bits, words       Search     search event setup     frame content, error       frame content, error     data; conditions =, ≠, <, ≤, >, ≥, in range, out of range		1 2 2 2 2 2 2 2 2 2 2 2 2 2 2 2 2 2 2 2	
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$		differential AC autout level ( DOC (2.2)	
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$		differential AC output levels for DQS (9.3)	
SQQdiff falling         DDR4 decoding         Protocol configuration       signal type       DQ, DQS         bit rate       adjustable         threshold setup       manual threshold/hysteresis configuration         source       analog channels         decoded bus, tabulated list, details         color coding       read frame, write frame         data format       hex, octal, binary, signed, unsigned         decode layer       edges, bits, words         Search       search event setup       frame content, error         frame content       data; conditions =, ≠, <, ≤, >, ≥, in range, out of range			VOLdiff(AC)
SQQdiff falling         DDR4 decoding         Protocol configuration       signal type       DQ, DQS         bit rate       adjustable         threshold setup       manual threshold/hysteresis configuration         source       analog channels         decoded bus, tabulated list, details         color coding       read frame, write frame         data format       hex, octal, binary, signed, unsigned         decode layer       edges, bits, words         Search       search event setup       frame content, error         frame content       data; conditions =, ≠, <, ≤, >, ≥, in range, out of range		differential output slew rate for DQS (9.5)	SRQdiff rising
DDR4 decoding         Protocol configuration       signal type bit rate adjustable threshold setup manual threshold/hysteresis configuration source analog channels         Decode       display type decoded bus, tabulated list, details color coding read frame, write frame data format hex, octal, binary, signed, unsigned decode layer edges, bits, words         Search       search event setup frame content, error data; conditions =, $\neq$ , <, ≤, >, ≥, in range, out of range			
Protocol configuration $\begin{array}{cccccccccccccccccccccccccccccccccccc$	DDD4 deceding		owwin raining
bit rate adjustable threshold setup manual threshold/hysteresis configuration source analog channels  Decode display type decoded bus, tabulated list, details color coding read frame, write frame data format hex, octal, binary, signed, unsigned decode layer edges, bits, words  Search search event setup frame content, error frame content data; conditions =, ≠, <, ≤, >, ≥, in range, out of range			
bit rate adjustable threshold setup manual threshold/hysteresis configuration source analog channels  Decode display type decoded bus, tabulated list, details color coding read frame, write frame data format hex, octal, binary, signed, unsigned decode layer edges, bits, words  Search search event setup frame content, error frame content data; conditions =, ≠, <, ≤, >, ≥, in range, out of range	Protocol configuration	signal type	DQ, DQS
threshold setup manual threshold/hysteresis configuration source analog channels  Decode display type decoded bus, tabulated list, details color coding read frame, write frame data format hex, octal, binary, signed, unsigned decode layer edges, bits, words  Search search event setup frame content, error data; conditions $=$ , $\neq$ , $<$ , $\leq$ , $>$ , $\geq$ , in range, out of range			
$\begin{array}{c ccccccccccccccccccccccccccccccccccc$			
Decode $ \begin{array}{c} \text{display type} & \text{decoded bus, tabulated list, details} \\ \text{color coding} & \text{read frame, write frame} \\ \text{data format} & \text{hex, octal, binary, signed, unsigned} \\ \text{decode layer} & \text{edges, bits, words} \\ \text{Search} & \text{search event setup} & \text{frame content, error} \\ \text{frame content} & \text{data; conditions} =, \neq, <, \leq, >, \geq, \text{ in range, out of range} \\ \end{array} $		•	
color codingread frame, write framedata formathex, octal, binary, signed, unsigneddecode layeredges, bits, wordsSearchsearch event setupframe content, errorframe contentdata; conditions =, $\neq$ , <, ≤, >, ≥, in range, out of range			
data formathex, octal, binary, signed, unsigneddecode layeredges, bits, wordsSearchsearch event setupframe content, errorframe contentdata; conditions =, ≠, <, ≤, >, ≥, in range, out of range	Decode	display type	decoded bus, tabulated list, details
data formathex, octal, binary, signed, unsigneddecode layeredges, bits, wordsSearchsearch event setupframe content, errorframe contentdata; conditions =, ≠, <, ≤, >, ≥, in range, out of range			read frame, write frame
$\begin{array}{cccccccccccccccccccccccccccccccccccc$		· · · · · · · · · · · · · · · · · · ·	
Search search event setup frame content, error data; conditions =, $\neq$ , <, $\leq$ , >, $\geq$ , in range, out of range			
frame content data; conditions =, $\neq$ , <, $\leq$ , >, $\geq$ , in range, out of range		,	
frame content data; conditions =, $\neq$ , <, $\leq$ , >, $\geq$ , in range, out of range	Search	search event setup	frame content, error
out of range		•	
error length, frame incomplete			
		error	length, frame incomplete

DDR4 eye diagram General description	The DDR4 eve diagram allows the use	r to generate eve diagrams from long multi-	
Oeneral description	The DDR4 eye diagram allows the user to generate eye diagrams from long multi- period acquisitions of clock signals and serial data signals. It allows the fine control of the signal content that contributes to the eye diagram and enables the advanced analysis, measurement, mask test and navigation functions.		
General configuration	number of eye diagram instances	up to 4; independently configurable	
	main source	analog channels, math channels, reference channels	
	timing reference source	analog channels, math channels, reference channels	
	horizontal settings	range, position; expressed in absolute time or relative to user-defined bit rate	
Display	persistence	50 ms to 50 s, or infinite	
-	trace colors	predefined or user-defined color tables	
	eye stripe	displays position of eye diagram slices and masks violations time-correlated to the main source waveform; always enabled, for mask tests only, disabled	
Qualification	gate	,	
	position	start, stop; absolute time or relative to display in percent	
	coupling	none, cursor #, zoom #	
	signal		
	source	analog channels, math channels, reference channels	
	condition	greater than, less than; relative to selected reference level	
Filter	DDR4 protocol		
	frame type	any, read frame, non-consecutive read frame, write frame, non-consecutive write frame	
	error	length	
	bit sequence		
	mode	all, level transition, constant level, bit pattern	
	bit pattern setup	up to 8 prefix bits and up to 5 suffix bits with respect to central eye diagram bit	
Mask testing	mask test results		
g	counters	acquisitions, slices, sample hits, slice hits fail rate	
	violation details	number and position of mask violation, expressed as time instant and slice index	
	navigation and zoom	use zoom coupling to navigate to violation upon clicking the corresponding table iter	

### R&S®RTP-K99 R&S®ScopeSuite automation

The option is used in combination with the free-of-charge R&S®ScopeSuite PC software, which can be downloaded from the Rohde & Schwarz website. It requires matching compliance test options (see below). R&S®RTP-K99 makes it possible to automate the supported compliance options remotely. After remote execution of a test case the user can collect the results to process them in a proprietary software to create own reports.

Remote API to execute test cases of R&S®ScopeSuite		
API language		C#
Supported options	R&S®RTP-K22	100BASE-TX, 1000BASE-T
	R&S®RTP-K24	100BASE-T1
	R&S®RTP-K87	1000BASE-T1
	R&S®RTP-K91	DDR3, DDR3L, LPDDR3
	R&S®RTP-K93	DDR4, LPDDR4, LPDDR4X

# R&S®RTP-K101 USB 3.2 transmitter compliance test

The option is used in combination with the free-of-charge R&S®ScopeSuite PC software, which can be downloaded from the Rohde & Schwarz website. R&S®RTP-K101 performs USB 2.0/3.2 compliance test measurements with R&S®ScopeSuite. R&S®ScopeSuite supports Windows 7, 8 and 10.

Supported USB 3.2 compliance		
USB 2.0 device test	high speed	signal quality (EL_2, 4, 5, 6, 7); packet parameters (EL_21, 22, 25); chirp timing (EL_28, 29, 31); suspend/resume/reset timing (EL_27, 28, 38, 39, 40); test J/K, SE0_NAK (EL_8, 9); receiver sensitivity (EL_16, 17, 18)
	full speed and low speed	full speed signal quality; back voltage; inrush current
USB 2.0 host test	high speed	signal quality (EL_2, 3, 6, 7); packet parameters (EL_21, 22, 23, 25, 55); chirp timing (EL_33, 34, 35); suspend/resume/reset timing (EL_39, 41); test J/K, SE0_NAK (EL_8, 9)
	full speed and low speed	low speed signal quality downstream; full speed signal quality downstream; drop; droop
USB 2.0 hub test	high speed	signal quality upstream (EL_2, 4, 6, 7); signal quality downstream (EL_2, 3, 6, 7); jitter downstream (EL_47); packet parameters upstream (EL_21, 22, 25); hub receiver sensitivity upstream (EL_16, 17, 18); repeater downstream (EL_42, 43, 44, 45, 48); repeater upstream (EL_42, 43, 44, 45); chirp timing upstream (EL_28, 29, 31); suspend/resume/reset timing upstream (EL_27, 28, 38, 39, 40); test J/K, SEO_NAK upstream (EL_8, 9); test J/K, SEO_NAK downstream (EL_8, 9)
	full speed and low speed	low speed signal quality downstream; full speed signal quality upstream; full speed signal quality downstream; inrush current upstream; drop downstream; droop downstream; back voltage
USB 3.2 device test	SuperSpeed (Gen 1)	TD 1.1: low frequency periodic signaling TX; TD 1.3: long channel transmitted eye; TD 1.3: short channel transmitted eye; TD 1.6: SSC profile
	SuperSpeedPlus (Gen 2)	TD 1.4: long channel transmitted eye; TD 1.4: short channel transmitted eye; TD 1.5: transmit equalization; TD 1.7: SSC profile
USB 3.2 host test	SuperSpeed (Gen 1)	TD 1.1: low frequency periodic signaling TX; TD 1.3: long channel transmitted eye; TD 1.3: short channel transmitted eye; TD 1.6: SSC profile
	SuperSpeedPlus (Gen 2)	TD 1.4: long channel transmitted eye; TD 1.4: short channel transmitted eye; TD 1.5: transmit equalization; TD 1.7: SSC profile

USB 3.2 hub test	SuperSpeed (Gen 1)	TD 1.1: upstream low frequency periodic signaling TX; TD 1.3: upstream long channel transmitted eye; TD 1.3: upstream short channel transmitted eye; TD 1.6: upstream SSC profile; TD 1.1: downstream low frequency periodic signaling TX; TD 1.3: downstream long channel transmitted eye; TD 1.3: downstream short channel transmitted eye; TD 1.6: downstream SSC profile
	SuperSpeedPlus (Gen 2)	TD 1.4: upstream long channel transmitted eye; TD 1.4: upstream short channel transmitted eye; TD 1.5: upstream transmit equalization; TD 1.7: upstream SSC profile; TD 1.4: downstream long channel transmitted eye; TD 1.4: downstream short channel transmitted eye; TD 1.5: downstream transmit equalization TD 1.7: downstream SSC profile

### R&S®RTP-K110 HDMI 1.4/2.1 TMDS compliance test

The option is used in combination with the free-of-charge R&S $^{\circ}$ ScopeSuite PC software, which can be downloaded from the Rohde & Schwarz website. R&S $^{\circ}$ RTP-K110 performs HDMI 1.4b / 2.1 TMDS transmitter compliance test measurements with R&S $^{\circ}$ ScopeSuite. R&S $^{\circ}$ ScopeSuite supports Windows 7, 8 and 10.

Supported HDMI compliance tes	sts	
HDMI 1.4b clock	all clock tests	V <sub>I</sub> +, V <sub>I</sub> – (7-2)
		rise/fall time (7-4)
		intra pair skew (7-7)
		duty cycle min./max. (7-8)
		jitter (7-9)
	voltage off tests	$V_{\text{off}}$ +, $V_{\text{off}}$ – (7-3)
HDMI 1.4b data	single-ended tests	V <sub>1</sub> +, V <sub>1</sub> – (7-2)
		intra pair skew (7-7)
	voltage off tests	$V_{off} +, V_{off} - (7-3)$
	differential timing tests	rise/fall time (7-4)
	jitter mask tests	differential voltage mask (7-10)
		jitter (7-10)
	inter-pair skew	inter pair skew (7-6)
HDMI 2.1 TMDS clock	all clock tests	V₁+, V₁– (HF 1-1)
		$V_{\text{swing}}$ +, $V_{\text{swing}}$ – (HF 1-1)
		rise/fall time (HF 1-2)
		intra pair skew (HF 1-4)
		duty cycle min./max. (HF 1-6)
		rate (HF 1-6)
		V <sub>swing</sub> TP1 (HF 1-7)
		jitter worst case pos/neg skew (HF 1-7)
HDMI 2.1 TMDS data	single-ended tests	V <sub>I</sub> +, V <sub>I</sub> – (HF 1-1)
		$V_{\text{swing}}$ +, $V_{\text{swing}}$ – (HF 1-1)
		intra pair skew (HF 1-4)
	differential timing tests	rise/fall time (HF 1-2)
	differential voltage mask tests	max./min. differential voltage (HF 1-5)
	jitter mask tests	mask test worst case pos/neg skew
		(HF 1-8)
	inter-pair skew	inter-pair skew (HF 1-3)

### R&S®RTP-K121 deembedding base option

General description	The R&S®RTP-K121 deembedding base option allows waveform correction based on S-parameters of the involved measurement blocks. The correction parameters of a cable or a modified probe can also be determined by using proven cable/proven probe.	
Source	channel 1, channel 2, channel 3,	
	channel 4,	
Signal types	single-ended signals	
	differential signals based on two separate	
	cables by using two channels	
	full differential signals based on	
	differential probes	
S-parameter files	s2p-files and s4p-files	
Types of blocks	cables, connectors, fixtures and customer	
	defined blocks	
Maximum number of blocks	10	

### Proven cable/proven probe

General description	Proven probe/cable is a part of the R&S®RTP-K121 deembedding base option. This function enables the user to determine the correction parameters of a cable or a		
	modified probe based on the R&S®RTP-B7 differential pulse source.		
Mode	·	proven cable	
		proven probe (Rohde & Schwarz probes, user defined)	
Configurations	proven cable	single ended	
	proven probe	single ended, differential	
Correction method	cable, user defined probe	transmission (magnitude and phase)	
	Rohde & Schwarz probe	transmission (magnitude and phase)	
Maximal group delay of DUT	·	20 ns	
Maximal length of cables (setup)		3 m	
Source		step with amplitude of -200 mV	

### R&S®RTP-K122 realtime deembedding extension

General description	The R&S®RTP-K122 realtime deembedding extension option allows waveform	
	correction based on S-parameters in realtime. This option is an extension to the	
	R&S®RTP-K121 deembedding base option. For details, see R&S®RTP-K121 option.	
Realtime waveform acquisition rate	see acquisition system	

# R&S®RTP-K130 TDR/TDT analysis

	nain transmission analysis option	ntion is a massurement to shaigue used to determine	
General description	The R&S®RTP-K130 TDR/TDT option is a measurement technique used to determine		
		es by observing reflected and/or transmitted	
		de a powerful means of analyzing electrical	
	transmission media.		
Mode		TDR, TDT, TDR/TDT	
Configuration		single ended, full differential	
Signals		impedance/reflection coefficient	
Domain		time/distance	
Bandwidth	TDR and/or TDT, single ended		
	R&S®RTP044	4 GHz	
	R&S®RTP064	6 GHz	
	R&S®RTP084	8 GHz	
	R&S®RTP134	13 GHz	
	R&S®RTP164	16 GHz	
	TDR or TDT, differential		
	R&S®RTP044	4 GHz	
	R&S®RTP064	6 GHz	
	R&S®RTP084	8 GHz	
	R&S®RTP134	13 GHz	
	R&S®RTP164	16 GHz	
	TDR and TDT, differential	10 0112	
	R&S®RTP044	4 GHz	
	R&S®RTP064	6 GHz	
	R&S®RTP084	8 GHz	
	R&S®RTP134		
		8 GHz	
	R&S®RTP164	8 GHz	
Step amplitude		200 mV	
Repetition rate		50 Hz to 500 kHz	
		(depends on horizontal scale)	
Length of cable	max.	15 ns ( $\sim$ 3.2 m at $\epsilon_r$ = 2 )	
	min.	2 ns ( $\sim$ 0.4 m at $\varepsilon_r$ = 2 )	
Electrical length of short	range, adjustable by user	0 ns to 2 ns	
Reference impedance	single ended	50 Ω	
	differential	100 Ω	

# R&S®RTP-K133 advanced jitter analysis

General description		The R&S®RTP-K133 option provides advanced jitter measurements and enables jitter separation. R&S®RTP-K133 option includes R&S®RTP-K12 option.	
Jitter separation	total jitter (TJ),		
onter separation	deterministic jitter (DJ),		
	data dependent jitter (DDJ),		
	periodic jitter (PJ),		
	data dependent jitter plus periodic jitter (	DD I+B I)	
	random jitter (RJ),	DD311 3),	
	(other) bounded uncorrelated jitter ((O)B	111)	
	random jitter plus (other) bounded uncor		
Accepted input signals	clock signals or data signals (NRZ)	related filter (No 1 (O)DOO)	
Reference clock	internal clock recovery (PLL first or seco	nd order constant clock or feed forward)	
reference clock	or explicit clock signal	nd order, constant clock or leed forward)	
Dania manauramanta	symbol rate, symbol duration, event cou	^t	
Basic measurements			
Jitter measurements	total jitter at bit error rate (TJ@BER)	value in seconds or unit interval BER value selectable	
		between 10 <sup>-32</sup> and 10 <sup>-1</sup>	
	dotorministic litter (D.L. duel direct		
	deterministic jitter (DJ, dual-dirac)	value in seconds or unit interval	
	duty cycle distortion (DCD)	value in seconds or unit interval	
	inter symbol interference (ISI)	value in seconds or unit interval	
	total jitter (TJ) corresponds to	peak-to-peak value and RMS value in	
	time interval error (TIE)	seconds or unit interval	
	deterministic jitter (DJ)	peak-to-peak value and RMS value in	
		seconds or unit interval	
	data dependent jitter (DDJ)	peak-to-peak value and RMS value in	
		seconds or unit interval	
	periodic jitter (PJ)	peak-to-peak value and RMS value in	
		seconds or unit interval	
	data dependent jitter plus periodic jitter	peak-to-peak value and RMS value in	
	(DDJ+PJ)	seconds or unit interval	
	periodic jitter components	amplitude, frequency,	
		direction (vertical or horizontal)	
	random jitter (RJ)	RMS value in seconds or unit interval	
	(other) bounded uncorrelated jitter	peak-to-peak value and RMS value in	
	((O)BUJ)	seconds or unit interval	
	(other) bounded uncorrelated jitter ((O)BUJ, dual-dirac)	value in seconds or unit interval	
	random jitter plus (other) bounded	peak-to-peak value and RMS value in	
	uncorrelated jitter (RJ+(O)BUJ)	seconds or unit interval	
Statistics		max. and min. values for each jitter measurement type	
litter result plots	histogram (rising edges only)	TJ, DJ, DDJ, PJ, RJ+OBUJ	
-	histogram (falling edges only)	TJ, DJ, DDJ, PJ, RJ+OBUJ	
	histogram (both edges)	TJ, DJ, DDJ, PJ, RJ+OBUJ	
	TIE track	TJ, DDJ, PJ, RJ+OBUJ	
	power spectral density (PSD)	TJ, DDJ, PJ, RJ+OBUJ	
Additional result plots	step response	1 7 7 7 7 7 7 7	
	bathtub	PJ and (O)BUJ removable from noise	
		bathtub	
	synthetic eye diagram	DD only, DD+P(h), DD+P(v), DD+P	

# R&S®RTP-K134 advanced jitter and noise analysis

On a small day and afficial	The DOCRDTD KAOA andian manida a sha	and the same and a street and a street and	
General description	The R&S®RTP-K134 option provides advanced jitter and noise measurements and		
	separation. R&S®RTP-K134 option includes R&S®RTP-K133 advanced jitter analysis		
Naise concretion	option and R&S®RTP-K12 basic jitter analysis option.		
Noise separation		total noise (TN),	
	deterministic noise (DN),		
	data dependent noise (DDN),		
	periodic noise (PN),	(DDM - DM)	
	data dependent noise plus periodic noise (	(DDN+PN),	
	random noise (RN),	IA IV	
	(other) bounded uncorrelated noise ((OBU	, .	
	random noise plus other (other) bounded u	Incorrelated hoise (RN+(O)BUN)	
Accepted input signals	clock signals or data signals (NRZ)		
Reference clock	internal clock recovery (PLL first or second or explicit clock signal	d order, constant clock or feed forward)	
Basic measurements	symbol rate, symbol duration, event count		
Noise measurements	eye height at bit error rate (EN@BER)	absolute or relative,	
		BER value selectable	
		between 10 <sup>-32</sup> and 10 <sup>-1</sup>	
	level distortion (LD)	absolute or relative value	
	inter symbol interference noise (ISIN)	absolute or relative value	
	total noise (TN)	peak-to-peak value and RMS value,	
	, ,	absolute or relative	
	deterministic noise (DN)	peak-to-peak value and RMS value,	
	, ,	absolute or relative	
	data dependent noise (DDN)	peak-to-peak value and RMS value,	
		absolute or relative	
	periodic noise (PN)	peak-to-peak value and RMS value,	
		absolute or relative	
	data dependent noise plus periodic noise	peak-to-peak value and RMS value,	
	(DDN+PN)	absolute or relative	
	periodic noise components	amplitude, frequency,	
		direction (vertical or horizontal)	
	random noise (RN)	RMS value, absolute or relative	
	(other) bounded uncorrelated noise	peak-to-peak value and RMS value,	
	((O)BÚN)	absolute or relative	
	(other) bounded uncorrelated noise	absolute or relative value	
	((O)BUN, dual-dirac),		
	random noise plus (other) bounded	peak-to-peak value and RMS value,	
	uncorrelated noise (RJ+(O)BUN)	absolute or relative	
Statistics	max. and min. values for each noise measurement type		
Noise result plots	histogram (level 0)	TN, DN, DDN, PN, RN+OBUN	
	histogram (level 1)	TN, DN, DDN, PN, RN+OBUN	
	histogram (both levels)	TN, DN, DDN, PN, RN+OBUN	
	TIE track	TN, DDN, PN, RN+OBUN	
	power spectral density (PSD)	TN, DDN, PN, RN+OBUN	
Additional result plots	step responses	· · · · · · · · · · · · · · · · · · ·	
•	noise bathtub	PN and (O)BUN removable from noise	
		bathtub	
	synthetic eye diagram	DD only, DD+P(h), DD+P(v), DD+P	

# R&S®RTP-K140 high speed serial pattern trigger (8 Gbps)

General description	The R&S®RTP-K140 high speed serial pattern trigger option provides triggering functions for simple or complex combinations of bit patterns or 8b10b words up to a bit	
	rate of 8 Gbps including clock da	<b>-</b>
Source	data	any analog channel
	clock	any analog channel or extracted from data
		channel by using a clock data recovery
Trigger types	single bit pattern	up to 160 bit; wildcards supported
	dual bit pattern	two bit patterns with 160 bit each connected with logical OR; wildcards supported
	complex word pattern	frame alignment by bit pattern of up to
	, , , ,	32 bit or timeout; up to 4 bit patterns (up
		to 160 bit in total) connected with logical
		AND or OR; conditions: $=$ , $\neq$ , $<$ , $>$ , $\geq$ , $\leq$ , in
		range, out of range; bit offset, length and search range definable for each pattern
	8b10b	aligns on selectable comma symbol; trigger condition of up to 16 K/D symbols including wildcards; disparity error, symbol error
	PRBS error	locks to PRBS sequences of type 7, 9, 11, 15, 16, 17, 20, 23, 29, 31 and triggers on error
Clock data recovery	bit rate	21 kbps to 8 Gbps; supports bit rate estimation
	unit interval position	0 to 1

# R&S®RTP-K141 high speed serial pattern trigger (16 Gbps)

General description	The R&S®RTP-K141 high speed serial pattern trigger option provides triggering functions for simple or complex combinations of bit patterns or 8b10b words up to a bit rate of 16 Gbps including clock data recovery.			
Source	data	any analog channel		
	clock	any analog channel or extracted from data channel by using a clock data recovery		
Trigger types	single bit pattern	up to 160 bit; wildcards supported		
	dual bit pattern	two bit patterns with 160 bit each connected with logical OR; wildcards supported		
	complex word pattern	frame alignment by bit pattern of up to 32 bit or timeout; up to 4 bit patterns (up to 160 bit in total) connected with logical AND or OR; conditions: =, ≠, <, >, ≥, ≤, in range, out of range; bit offset, length and search range definable for each pattern		
	8b10b	aligns on selectable comma symbol; trigger condition of up to 16 K/D symbols including wildcards; disparity error, symbol error		
	PRBS error	locks to PRBS sequences of type 7, 9, 11, 15, 16, 17, 20, 23, 29, 31 and triggers on error		
	128b132b	aligns on selectable word; triggers on selectable word		
Clock data recovery	bit rate	21 kbps to 16 Gbps; supports bit rate estimation		
	unit interval position	0 to 1		

# **Ordering information**

Designation	Туре	Order No.
Base unit (including standard accessories: R&S®RT-ZA16 precision BNC to SM		II.
High-performance oscilloscope		<u> </u>
4 GHz, 50 Msample memory	R&S®RTP044	1320.5007.04
6 GHz, 50 Msample memory	R&S®RTP064	1320.5007.06
3 GHz, 50 Msample memory	R&S®RTP084	1320.5007.08
13 GHz, 50 Msample memory	R&S®RTP134	1320.5007.13
16 GHz, 50 Msample memory	R&S®RTP164	1320.5007.16
Hardware options (plug-in)	11.000 11.11 101	1020.0000
Mixed signal option, 400 MHz	R&S®RTP-B1	1333.2424.02
Digital extension port for R&S®RT-ZVC usage with R&S®RTP oscilloscope,	R&S®RTP-B1E	1337.9581.02
included in R&S®RTP-B1	INGO INTI BIL	1007.0001.02
Arbitrary waveform generator, 100 MHz, 2 analog channels, 8-bit pattern	R&S®RTP-B6	1333.2418.02
generator	INGO INTI BO	1000.2410.02
16 GHz differential pulse source	R&S®RTP-B7	1333.2001.02
Adapter rear option slot	R&S®RTP-B21	1338.0507.02
Additional solid state disk	R&S®RTP-B19	1337.9498.02
Memory upgrade, 100 Msample per channel	R&S®RTP-B101	1337.9500.02
Memory upgrade, 100 Msample per channel  Memory upgrade, 200 Msample per channel	R&S®RTP-B101	1337.9500.02
Memory upgrade, 500 Msample per channel	R&S®RTP-B105	1337.9523.02
Memory upgrade, 300 Msample per channel  Memory upgrade, 1 Gsample per channel	R&S®RTP-B100	1337.9530.02
Memory upgrade, 1 Gsample per channel  Bandwidth upgrades 13	Nαο KIP-DIIU	1007.9000.02
	R&S®RTP-B0406	1227 0200 02
Upgrade of the R&S®RTP044 to 6 GHz bandwidth		1337.9398.02
Upgrade of the R&S®RTP044 to 8 GHz bandwidth	R&S®RTP-B0408	1337.9400.02
Upgrade of the R&S®RTP044 to 13 GHz bandwidth	R&S®RTP-B0413	1801.3707.02
Upgrade of the R&S®RTP044 to 16 GHz bandwidth	R&S®RTP-B0416	1801.3713.02
Upgrade of the R&S®RTP064 to 8 GHz bandwidth	R&S®RTP-B0608	1337.9430.02
Upgrade of the R&S®RTP064 to 13 GHz bandwidth	R&S®RTP-B0613	1801.3720.02
Upgrade of the R&S®RTP064 to 16 GHz bandwidth	R&S®RTP-B0616	1801.3736.02
Upgrade of the R&S®RTP084 to 13 GHz bandwidth	R&S®RTP-B0813	1801.3742.02
Upgrade of the R&S®RTP084 to 16 GHz bandwidth	R&S®RTP-B0816	1801.3759.02
Upgrade of the R&S®RTP134 to 16 GHz bandwidth	R&S®RTP-B1316	1801.3765.02
Software options		
Serial triggering and decoding		
I <sup>2</sup> C/SPI serial triggering and decoding	R&S®RTP-K1	1337.8604.02
UART/RS-232/RS-422/RS-485 serial triggering and decoding	R&S®RTP-K2	1337.8610.02
CAN/LIN serial triggering and decoding	R&S®RTP-K3	1337.8627.02
MIL-STD-1553 serial triggering and decoding	R&S®RTP-K6	1800.6654.02
ARINC 429 serial triggering and decoding	R&S®RTP-K7	1800.6660.02
Ethernet (10BASE-T/100BASE-TX) serial triggering and decoding	R&S®RTP-K8	1337.8633.02
CAN-FD serial triggering and decoding	R&S®RTP-K9	1337.8640.02
MIPI RFFE serial triggering and decoding	R&S®RTP-K40	1337.8733.02
MIPI D-PHY serial triggering and decoding	R&S®RTP-K42	1337.8740.02
MIPI M-PHY serial triggering and decoding	R&S®RTP-K44	1337.8756.02
Manchester and NRZ serial triggering and decoding	R&S®RTP-K50	1337.8762.02
8b10b serial triggering and decoding	R&S®RTP-K52	1337.8779.02
MDIO serial triggering and decoding	R&S®RTP-K55	1337.8785.02
Ethernet (100BASE-T1) serial triggering and decoding	R&S®RTP-K57	1800.6548.02
Ethernet (1000BASE-T1) serial triggering and decoding	R&S®RTP-K58	1800.6702.02
USB 1.0/1.1/2.0 serial triggering and decoding	R&S®RTP-K60	1337.8791.02
USB 3.1 Gen 1 serial triggering and decoding	R&S®RTP-K61	1337.8804.02
USB 3.1 Gen 2 serial triggering and decoding	R&S®RTP-K62	1337.9100.02
USB power delivery serial triggering and decoding	R&S®RTP-K63	1337.8810.02
USB 3.1 SSIC serial triggering and decoding	R&S®RTP-K64	1337.9117.02
SpaceWire serial triggering and decoding	R&S®RTP-K65	1800.6677.02
PCI Express 1.1/2.0 serial triggering and decoding	R&S®RTP-K72	1337.8827.02
i Oi Express 1.1/2.0 seriai triggering and decoding	R&S®RTP-K73	1800.6960.02

<sup>13</sup> The bandwidth upgrade is performed at a Rohde & Schwarz service center, where the oscilloscope will also be calibrated.

Designation Compliance tests	Туре	Order No.
USB 2.0 compliance test	R&S®RTP-K21	1337.8685.02
Ethernet compliance test (10/100/1000BASE-T/EEE)	R&S®RTP-K22	1337.8691.02
Ethernet compliance test (10/100/1000BASE-1/LEE)  Ethernet compliance test (2.5/5/10GBASE-T)	R&S®RTP-K23	1337.8704.02
Ethernet compliance test (2.3/3/10GBASE-1)  Ethernet compliance test (100BASE-T1)	R&S®RTP-K24	1800.6531.02
	R&S®RTP-K26	
MIPI-D-PHY compliance test	R&S®RTP-K81	1337.8727.02
PCI Express 1.1/2.0 compliance test	R&S®RTP-K83	1337.8885.02
PCI Express 1.1/2.0/3.0 compliance test		1800.6954.02
Ethernet compliance test (1000BASE-T1)	R&S®RTP-K87	1800.6554.02
Ethernet compliance test (MGBASE-T1)	R&S®RTP-K88	1800.6725.02
Ethernet compliance test (10BASE-T1)	R&S®RTP-K89	1800.6719.02
DDR3/DDR3L/LPDDR3 signal integrity debug and compliance test	R&S®RTP-K91	1337.8840.02
eMMC compliance test	R&S®RTP-K92	1803.6378.02
DDR4/LPDDR4 signal integrity debug and compliance test	R&S®RTP-K93	1801.3671.02
R&S®ScopeSuite automation	R&S®RTP-K99	1326.4425.02
USB 3.2 transmitter compliance test	R&S®RTP-K101	1800.6948.02
HDMI 1.4/2.1 TMDS compliance test	R&S®RTP-K110	1802.9467.02
Analysis		
I/Q software interface	R&S®RTP-K11	1800.6683.02
Jitter analysis	R&S®RTP-K12	1337.8656.02
Zone trigger	R&S®RTP-K19	1337.8879.02
Bus analysis	R&S®RTP-K35	1800.6648.02
Spectrogram	R&S®RTP-K37	1338.1110.02
Deembedding base option	R&S®RTP-K121	1326.3064.02
Realtime deembedding extension	R&S®RTP-K122	1326.3070.02
TDR/TDT analysis	R&S®RTP-K130	1326.3093.02
Advanced jitter analysis	R&S®RTP-K133	1800.6860.02
Advanced jitter and noise analysis	R&S®RTP-K134	1800.6977.02
High speed serial pattern trigger (8 Gbps)	R&S®RTP-K140	1326.4554.02
High speed serial pattern trigger (16 Gbps)	R&S®RTP-K141	1326.4560.02
Probes	Kas KIF-KI4I	1320.4300.02
****	D 0 0 0 D T 7700	4 400 7000 00
8.0 GHz transmission line probe, 10:1, 500 Ω, 0.3 pF, 20 V (RMS)	R&S®RT-ZZ80	1409.7608.02
3.0 GHz active voltage probe, single-ended, 1 MΩ, 0.8 pF	R&S®RT-ZS30	1410.4309.02
5.0 GHz active voltage probe, single-ended, 1 M $\Omega$ , 0.3 pF	R&S®RT-ZS60	1418.7307.02
4.0 GHz power rail probe, 1:1, low noise, 50 kΩ, large offset range ±60 V	R&S®RT-ZPR40	1800.5406.02
1.0 GHz active voltage probe, differential, 1 MΩ, 0.6 pF, incl. R&S®RT-ZA15	R&S®RT-ZD10	1410.4715.02
1.5 GHz active voltage probe, differential, 1 MΩ, 0.6 pF	R&S®RT-ZD20	1410.4409.02
3.0 GHz active voltage probe, differential, 1 MΩ, 0.6 pF	R&S®RT-ZD30	1410.4609.02
4.5 GHz active voltage probe, differential, 1 MΩ, 0.4 pF	R&S®RT-ZD40	1410.5205.02
6.0 GHz modular probe amplifier, differential, 400 kΩ, multimode	R&S®RT-ZM60	1419.3105.02
9.0 GHz modular probe amplifier, differential, 400 kΩ, multimode	R&S®RT-ZM90	1419.3205.02
Fip cable, solder in, length: 15 cm, multimode compatible	R&S®RT-ZMA10	1419.4301.02
Tip cable, square pin, for 1.27 mm pin header, length: 15 cm, multimode	R&S®RT-ZMA12	1419.4324.02
compatible		
Tip cable, quick connect, for solder in resistor connection, length: 15 cm,	R&S®RT-ZMA15	1419.4224.02
multimode		
Browser module, variable span from 0.5 mm to 8 mm, spring-loaded, multimode	R&S®RT-ZMA30	1419.4353.02
SMA module, 2.92 mm/3.5 mm/SMA, differential, 100 Ω, DC termination,	R&S®RT-ZMA40	1419.4201.02
multimode	TOO TO ZIVICTO	1110.1201.02
Extended temperature kit, 1 m matched cable pair, multimode compatible	R&S®RT-ZMA50	1419.4218.02
Multi-channel power probe, 2 × 4 voltage/current channels	R&S®RT-ZVC04	1326.0259.04
Multi-channel power probe, 2 x 4 voltage/current channels	R&S®RT-ZVC04	1326.0259.04
		1026.7744.03
Probe set for E and H near-field measurements, 9 kHz to 1 GHz	R&S®HZ-14	
Power supply, required for usage of R&S®HZ-14 near-field probe	R&S®HZ-9	0816.1015.03
Compact probe set for E and H near-field measurements, 30 MHz to 3 GHz	R&S®HZ-15	1147.2736.02
3 GHz, 20 dB preamplifier, 100 V to 230 V power adapter, for R&S®HZ-15	R&S®HZ-16	1147.2720.02
Probe accessories	D 0 00	= ac
High-impedance buffer amplifier, incl. 500 MHz passive probe	R&S®RT-Z1M	1337.9200.02
Spare accessory set for R&S®RT-ZS10/10E/20/30	R&S®RT-ZA2	1416.0405.02
Pin set for R&S®RT-ZS10/10E/20/30	R&S®RT-ZA3	1416.0411.02
Mini clips	R&S®RT-ZA4	1416.0428.02
Micro clips	R&S®RT-ZA5	1416.0434.02
_ead set	R&S®RT-ZA6	1416.0440.02
Pin set for R&S®RT-ZD20/30	R&S®RT-ZA7	1417.0609.02

Designation	Туре	Order No.
Probe box to N/USB adapter	R&S®RT-ZA9	1417.0909.02
External attenuator, 10:1, 2.0 GHz, 70 V DC, 46 V AC (peak)	R&S®RT-ZA15	1410.4744.02
Power rail browser kit	R&S®RT-ZA25	1800.5329.00
Pigtail cable, solder-in, length: 15 cm, for R&S®RT-ZPR20	R&S®RT-ZA26	1800.5258.00
3D probe positioner	R&S®RT-ZAP	1326.3641.02
Extended cable set for R&S®RT-ZVC, PCB probing, 1 current and voltage lead, length: 32 cm	R&S®RT-ZA30	1333.1686.02
Extended cable set for R&S®RT-ZVC, 4 mm probing, 1 current and voltage lead, length: 32 cm	R&S®RT-ZA31	1333.1692.02
Oscilloscope interface cable for R&S®RT-ZVC (included in R&S®RT-ZVC02/-ZVC04, 1326.0259.02/.04)	R&S®RT-ZA33	1333.1770.02
Extended cable set for R&S®RT-ZVC, 4 mm probing, 1 current and voltage lead, length: 1 m	R&S®RT-ZA34	1333.1892.02
Extended cable set for R&S®RT-ZVC, PCB probing, 1 current and voltage lead, length: 1 m	R&S®RT-ZA35	1333.1905.02
Solder-in cable set for R&S®RT-ZVC, 4 current and voltage solder-in cables, solder-in pins	R&S®RT-ZA36	1333.1911.02
Extended cable set for R&S®RT-ZVC, BNC connector, 1 current and voltage lead, length: 16 cm	R&S®RT-ZA37	1337.9130.02
Accessories		
Precision BNC to SMA adapter	R&S®RT-ZA16	1320.7074.02
Front cover, for R&S®RTP oscilloscopes	R&S®RTP-Z1	1337.9569.02
Front handles, for R&S®RTP oscilloscopes	R&S®RTP-B20	1338.0688.02
Transit case, for R&S®RTP oscilloscopes	R&S®RTP-Z4	1337.9575.02
Travel hard case, for R&S®RTP oscilloscopes and accessories	R&S®RTP-Z6	1338.0865.02
USB 2.0 compliance test fixture set	R&S®RT-ZF1	1317.3420.02
Ethernet compliance test fixture set	R&S®RT-ZF2	1317.5522.02
Frequency converter (100BASE-T1)	R&S®RT-ZF3	5025.0670.02
Ethernet 10BASE-Te fixture	R&S®RT-ZF4	1333.0915.02
Ethernet probe fixture	R&S®RT-ZF5	1333.0938.02
Frequency converter (1000BASE-T1)	R&S®RT-ZF6	1337.8579.02
Automotive Ethernet T&D fixture	R&S®RT-ZF7	1801.3688.02
SMA adapter	R&S®RT-ZF7A	1801.4126.02
Automotive Ethernet compliance fixture	R&S®RT-ZF8	1801.3694.02
Probe deskew and calibration test fixture	R&S®RT-ZF20	1800.0004.02
Probe test fixture	R&S®RT-ZF30	1333.2099.02
19" rackmount kit, for R&S®RTP oscilloscopes with 6 HU	R&S®ZZA-KN6	1175.3056.00

### Version 14.00, December 2021

Warranty		
Base unit	3 years	
All other items <sup>14</sup>	1 year	
Service options		
Extended warranty, one year	R&S®WE1	Please contact your local
Extended warranty, two years	R&S®WE2	Rohde & Schwarz sales
Extended warranty with calibration coverage, one year	R&S®CW1	office.
Extended warranty with calibration coverage, two years	R&S®CW2	
Extended warranty with accredited calibration coverage, one year	R&S®AW1	
Extended warranty with accredited calibration coverage, two years	R&S®AW2	

### Extended warranty with a term of one and two years (WE1 and WE2)

Repairs carried out during the contract term are free of charge <sup>15</sup>. Necessary calibration and adjustments carried out during repairs are also covered.

### Extended warranty with calibration coverage (CW1 and CW2)

Enhance your extended warranty by adding calibration coverage at a package price. This package ensures that your Rohde & Schwarz product is regularly calibrated, inspected and maintained during the term of the contract. It includes all repairs <sup>15</sup> and calibration at the recommended intervals as well as any calibration carried out during repairs or option upgrades.

#### Extended warranty with accredited calibration (AW1 and AW2)

Enhance your extended warranty by adding accredited calibration coverage at a package price. This package ensures that your Rohde & Schwarz product is regularly calibrated under accreditation, inspected and maintained during the term of the contract. It includes all repairs <sup>15</sup> and accredited calibration at the recommended intervals as well as any accredited calibration carried out during repairs or option upgrades.

<sup>14</sup> For options installed, the remaining base unit warranty applies if longer than 1 year. Exception: all batteries have a 1 year warranty.

<sup>&</sup>lt;sup>15</sup> Excluding defects caused by incorrect operation or handling and force majeure. Wear-and-tear parts are not included.

### Service that adds value

- Local and personalized
   Customized and flexible
   Uncompromising quality
   Long-term dependability

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- ► Energy efficiency and low emissions
- ► Longevity and optimized total cost of ownership

Certified Quality Management ISO 9001

Certified Environmental Management

ISO 14001

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